

FLASH MEMORY

CMOS

8M (1M × 8/512K × 16) BIT

MBM29LV800TA-90/-12/MBM29LV800BA-90/-12

■ FEATURES

- **Single 3.0 V read, program, and erase**
Minimizes system level power requirements
- **Compatible with JEDEC-standard commands**
Uses same software commands as E²PROMs
- **Compatible with JEDEC-standard world-wide pinouts**
48-pin TSOP(I) (Package suffix: PFTN – Normal Bend Type, PFTR – Reversed Bend Type)
44-pin SOP (Package suffix: PF)
48-ball FBGA (Package suffix: PBT)
- **Minimum 100,000 program/erase cycles**
- **High performance**
90 ns maximum access time
- **Sector erase architecture**
One 8K word, two 4K words, one 16K word, and fifteen 32K words sectors in word mode
One 16K byte, two 8K bytes, one 32K byte, and fifteen 64K bytes sectors in byte mode
Any combination of sectors can be concurrently erased. Also supports full chip erase
- **Boot Code Sector Architecture**
T = Top sector
B = Bottom sector
- **Embedded Erase™ Algorithms**
Automatically pre-programs and erases the chip or any sector
- **Embedded Program™ Algorithms**
Automatically writes and verifies data at specified address
- **Data Polling and Toggle Bit feature for detection of program or erase cycle completion**
- **Ready/Busy output (RY/BY)**
Hardware method for detection of program or erase cycle completion
- **Automatic sleep mode**
When addresses remain stable, automatically switch themselves to low power mode
- **Low V_{CC} write inhibit ≤ 2.5 V**
- **Erase Suspend/Resume**
Suspends the erase operation to allow a read in another sector within the same device

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MBM29LV800TA-90/-12/MBM29LV800BA-90/-12

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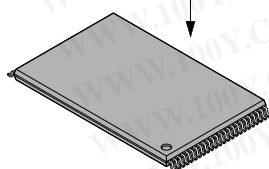
- **Sector protection**
Hardware method disables any combination of sectors from program or erase operations
- **Sector Protection set function by Extended sector Protect command**
- **Temporary sector unprotection**
Temporary sector unprotection via the **RESET** pin

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■ PACKAGE

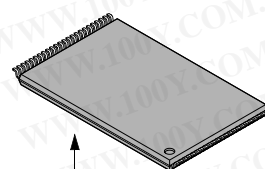
48-pin Plastic TSOP (I)

Marking Side



(FPT-48P-M19)

48-pin Plastic TSOP (I)

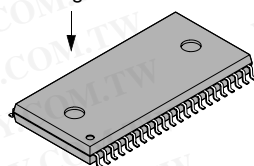


Marking Side

(FPT-48P-M20)

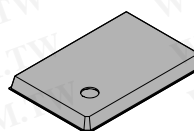
44-pin Plastic SOP

Marking Side



(FPT-44P-M16)

48-pin Plastic FBGA



(BGA-48P-M02)

MBM29LV800TA-90/-12/MBM29LV800BA-90/-12

■ GENERAL DESCRIPTION

The MBM29LV800TA/BA are a 8M-bit, 3.0 V-only Flash memory organized as 1M bytes of 8 bits each or 512K words of 16 bits each. The MBM29LV800TA/BA are offered in a 48-pin TSOP(I), 44-pin SOP, and 48-ball FBGA packages. These devices are designed to be programmed in-system with the standard system 3.0 V V_{CC} supply. 12.0 V V_{PP} and 5.0 V V_{CC} are not required for write or erase operations. The devices can also be reprogrammed in standard EPROM programmers.

The standard MBM29LV800TA/BA offer access times 90ns and 120 ns, allowing operation of high-speed microprocessors without wait states. To eliminate bus contention the devices have separate chip enable (\overline{CE}), write enable (\overline{WE}), and output enable (\overline{OE}) controls.

The MBM29LV800TA/BA are pin and command set compatible with JEDEC standard E²PROMs. Commands are written to the command register using standard microprocessor write timings. Register contents serve as input to an internal state-machine which controls the erase and programming circuitry. Write cycles also internally latch addresses and data needed for the programming and erase operations. Reading data out of the devices is similar to reading from 5.0 V and 12.0 V Flash or EPROM devices.

The MBM29LV800TA/BA are programmed by executing the program command sequence. This will invoke the Embedded Program Algorithm which is an internal algorithm that automatically times the program pulse widths and verifies proper cell margin. Typically, each sector can be programmed and verified in about 0.5 seconds. Erase is accomplished by executing the erase command sequence. This will invoke the Embedded Erase Algorithm which is an internal algorithm that automatically preprograms the array if it is not already programmed before executing the erase operation. During erase, the devices automatically time the erase pulse widths and verify proper cell margin.

A sector is typically erased and verified in 1.0 second. (If already completely preprogrammed.)

The devices also feature a sector erase architecture. The sector mode allows each sector to be erased and reprogrammed without affecting other sectors. The MBM29LV800TA/BA are erased when shipped from the factory.

The devices feature single 3.0 V power supply operation for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations. A low V_{CC} detector automatically inhibits write operations on the loss of power. The end of program or erase is detected by \overline{Data} Polling of DQ_7 , by the Toggle Bit feature on DQ_6 , or the RY/\overline{BY} output pin. Once the end of a program or erase cycle has been completed, the devices internally reset to the read mode.

Fujitsu's Flash technology combines years of EPROM and E²PROM experience to produce the highest levels of quality, reliability, and cost effectiveness. The MBM29LV800TA/BA memories electrically erase the entire chip or all bits within a sector simultaneously via Fowler-Nordhiem tunneling. The bytes/words are programmed one byte/word at a time using the EPROM programming mechanism of hot electron injection.

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■ FLEXIBLE SECTOR-ERASE ARCHITECTURE

- One 16K byte, two 8K bytes, one 32K byte, and fifteen 64K bytes
- Individual-sector, multiple-sector, or bulk-erase capability
- Individual or multiple-sector protection is user definable.

	(×8)	(×16)
16K byte	FFFFFH	7FFFFH
8K byte	FBFFFFH	7DFFFFH
8K byte	F9FFFFH	7CFFFFH
32K byte	F7FFFFH	7BFFFFH
64K byte	EFFFFFH	77FFFFH
64K byte	DFFFFFH	6FFFFFH
64K byte	CFFFFFH	67FFFFH
64K byte	BFFFFFH	5FFFFFH
64K byte	AFFFFFH	57FFFFH
64K byte	9FFFFFH	4FFFFFH
64K byte	8FFFFFH	47FFFFH
64K byte	7FFFFFH	3FFFFFH
64K byte	6FFFFFH	37FFFFH
64K byte	5FFFFFH	2FFFFFH
64K byte	4FFFFFH	27FFFFH
64K byte	3FFFFFH	1FFFFFH
64K byte	2FFFFFH	17FFFFH
64K byte	1FFFFFH	0FFFFFH
64K byte	0FFFFFH	07FFFFH
00000H	00000H	00000H

MBM29LV800TA Sector Architecture

	(×8)	(×16)
64K byte	FFFFFH	7FFFFH
64K byte	EFFFFFH	77FFFFH
64K byte	DFFFFFH	6FFFFFH
64K byte	CFFFFFH	67FFFFH
64K byte	BFFFFFH	5FFFFFH
64K byte	AFFFFFH	57FFFFH
64K byte	9FFFFFH	4FFFFFH
64K byte	8FFFFFH	47FFFFH
64K byte	7FFFFFH	3FFFFFH
64K byte	6FFFFFH	37FFFFH
64K byte	5FFFFFH	2FFFFFH
64K byte	4FFFFFH	27FFFFH
64K byte	3FFFFFH	1FFFFFH
64K byte	2FFFFFH	17FFFFH
64K byte	1FFFFFH	0FFFFFH
64K byte	0FFFFFH	07FFFFH
32K byte	07FFFFH	03FFFFH
8K byte	05FFFFH	02FFFFH
8K byte	03FFFFH	01FFFFH
16K byte	00000H	00000H

MBM29LV800BA Sector Architecture

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Part No.		MBM29LV800TA/MBM29LV800BA	
Ordering Part No.	V _{CC} = 3.0 V ^{+0.6 V} _{-0.3 V}	-90	-12
Max. Address Access Time (ns)		90	120
Max. $\overline{\text{CE}}$ Access Time (ns)		90	120
Max. $\overline{\text{OE}}$ Access Time (ns)		35	50

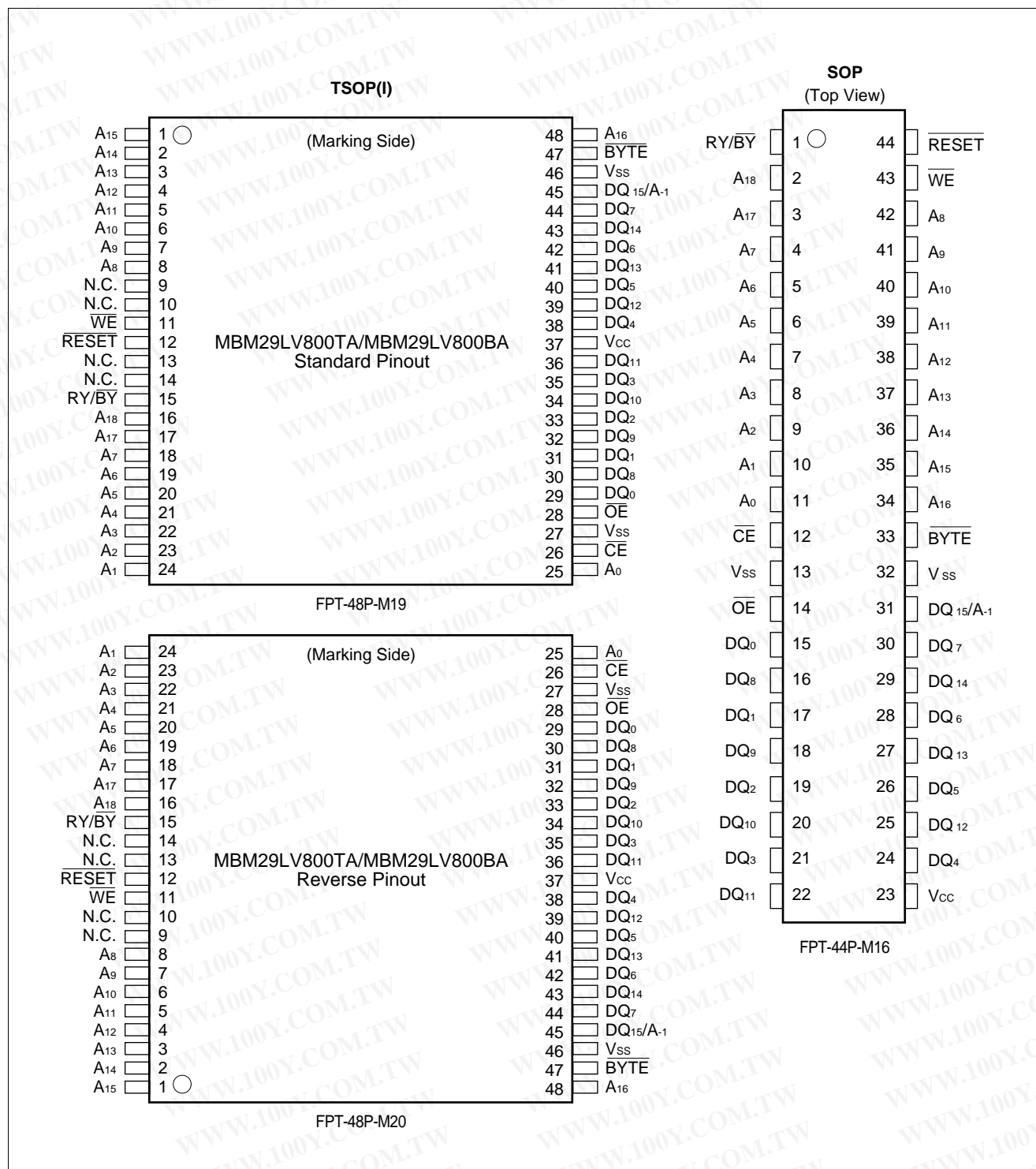
The block diagram illustrates the internal architecture of the 28C64 16Kbit EPROM. Key components and their interconnections include:

- Inputs:** V_{CC} , V_{SS} , \overline{WE} , \overline{BYTE} , \overline{RESET} , \overline{CE} , \overline{OE} , A_0 to A_{18} , and A_{-1} .
- Control and State:** The **State Control** and **Command Register** manage the device's operation. The **RY/ \overline{BY} Buffer** provides the RY/\overline{BY} output signal.
- Voltage Generation:** The **Erase Voltage Generator** and **Program Voltage Generator** provide the necessary voltages for erase and program operations, respectively. A **Low V_{CC} Detector** and **Timer for Program/Erase** are also present.
- Data Path:** The **Input/Output Buffers** handle data transfer between the device and the system bus (DQ_0 to DQ_{15}). The **Data Latch** and **Y-Gating** block are involved in data storage and access.
- Addressing:** The **Address Latch** and **X-Decoder** manage the address input (A_0 to A_{18} and A_{-1}). The **Y-Decoder** and **Cell Matrix** are used for data access.
- Chip Enable:** The **Chip Enable Output Enable Logic** generates the **STB** (Strobe) signal, which is used to enable the **Y-Decoder** and **Y-Gating** block.

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CONNECTION DIAGRAMS

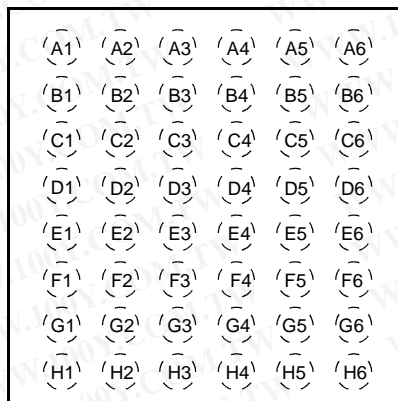


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(Continued)

FBGA
(Top View)
Marking side



BGA-48P-M02

A1	A3	A2	A7	A3	RY/BY	A4	WE	A5	A9	A6	A13
B1	A4	B2	A17	B3	N.C.	B4	RESET	B5	A8	B6	A12
C1	A2	C2	A6	C3	A18	C4	N.C.	C5	A10	C6	A14
D1	A1	D2	A5	D3	N.C.	D4	N.C.	D5	A11	D6	A15
E1	A0	E2	DQ ₀	E3	DQ ₂	E4	DQ ₅	E5	DQ ₇	E6	A16
F1	\overline{CE}	F2	DQ ₈	F3	DQ ₁₀	F4	DQ ₁₂	F5	DQ ₁₄	F6	BYTE
G1	\overline{OE}	G2	DQ ₉	G3	DQ ₁₁	G4	V _{CC}	G5	DQ ₁₃	G6	DQ _{15/A-1}
H1	V _{SS}	H2	DQ ₁	H3	DQ ₃	H4	DQ ₄	H5	DQ ₆	H6	V _{SS}

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LOGIC SYMBOL

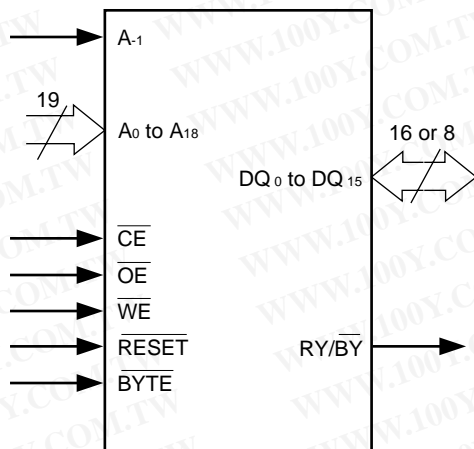


Table 1 MBM29LV800TA/800BA Pin Configuration

Pin	Function
A-1, A ₀ to A ₁₈	Address Inputs
DQ ₀ to DQ ₁₅	Data Inputs/Outputs
$\overline{\text{CE}}$	Chip Enable
$\overline{\text{OE}}$	Output Enable
$\overline{\text{WE}}$	Write Enable
RY/BY	Ready/Busy Output
RESET	Hardware Reset Pin/Temporary Sector Unprotection
BYTE	Selects 8-bit or 16-bit mode
N.C.	No Internal Connection
V _{SS}	Device Ground
V _{CC}	Device Power Supply

Table 2 MBM29LV800TA/800BA User Bus Operations (BYTE = V_{IH})

Operation	$\overline{\text{CE}}$	$\overline{\text{OE}}$	$\overline{\text{WE}}$	A ₀	A ₁	A ₆	A ₉	DQ ₀ to DQ ₁₅	RESET
Auto-Select Manufacturer Code (1)	L	L	H	L	L	L	V _{ID}	Code	H
Auto-Select Device Code (1)	L	L	H	H	L	L	V _{ID}	Code	H
Read (3)	L	L	H	A ₀	A ₁	A ₆	A ₉	D _{OUT}	H
Standby	H	X	X	X	X	X	X	HIGH-Z	H
Output Disable	L	H	H	X	X	X	X	HIGH-Z	H
Write (Program/Erase)	L	H	L	A ₀	A ₁	A ₆	A ₉	D _{IN}	H
Enable Sector Protection (2), (4)	L	V _{ID}		L	H	L	V _{ID}	X	H
Verify Sector Protection (2), (4)	L	L	H	L	H	L	V _{ID}	Code	H
Temporary Sector Unprotection	X	X	X	X	X	X	X	X	V _{ID}
Reset (Hardware)/Standby	X	X	X	X	X	X	X	HIGH-Z	L

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Table 3 MBM29LV800TA/800BA User Bus Operations (BYTE = V_{IL})

Operation	\overline{CE}	\overline{OE}	\overline{WE}	DQ_{15}/A_{-1}	A_0	A_1	A_6	A_9	DQ_0 to DQ_7	RESET
Auto-Select Manufacturer Code (1)	L	L	H	L	L	L	L	V_{ID}	Code	H
Auto-Select Device Code (1)	L	L	H	L	H	L	L	V_{ID}	Code	H
Read (3)	L	L	H	A_{-1}	A_0	A_1	A_6	A_9	D_{OUT}	H
Standby	H	X	X	X	X	X	X	X	HIGH-Z	H
Output Disable	L	H	H	X	X	X	X	X	HIGH-Z	H
Write (Program/Erase)	L	H	L	A_{-1}	A_0	A_1	A_6	A_9	D_{IN}	H
Enable Sector Protection (2), (4)	L	V_{ID}	\square	L	L	H	L	V_{ID}	X	H
Verify Sector Protection (2), (4)	L	L	H	L	L	H	L	V_{ID}	Code	H
Temporary Sector Unprotection (5)	X	X	X	X	X	X	X	X	X	V_{ID}
Reset (Hardware)/Standby	X	X	X	X	X	X	X	X	HIGH-Z	L

Legend: L = V_{IL} , H = V_{IH} , X = V_{IL} or V_{IH} , \square = Pulse input. See DC Characteristics for voltage levels.

- Notes:**
1. Manufacturer and device codes may also be accessed via a command register write sequence. See Table 7.
 2. Refer to the section on Sector Protection.
 3. \overline{WE} can be V_{IL} if \overline{OE} is V_{IL} , \overline{OE} at V_{IH} initiates the write operations.
 4. $V_{CC} = 3.3\text{ V} \pm 10\%$
 5. It is also used for the extended sector protection.

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■ ORDERING INFORMATION

Standard Products

Fujitsu standard products are available in several packages. The order number is formed by a combination of:

MBM29LV800 T A -90 PFTN

PACKAGE TYPE

PFTN = 48-Pin Thin Small Outline Package
(TSOP) Standard Pinout

PFTR = 48-Pin Thin Small Outline Package
(TSOP) Reverse Pinout

PF = 44-Pin Small Outline Package

PBT = 48-Ball Fine Pitch Ball Grid Array
Package (FBGA)

SPEED OPTION

See Product Selector Guide

Device Revision

BOOT CODE SECTOR ARCHITECTURE

T = Top sector

B = Bottom sector

DEVICE NUMBER/DESCRIPTION

MBM29LV800

8Mega-bit (1M × 8-Bit or 512K × 16-Bit) CMOS Flash Memory

3.0 V-only Read, Program, and Erase

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■ FUNCTIONAL DESCRIPTION

Read Mode

The MBM29LV800TA/BA have two control functions which must be satisfied in order to obtain data at the outputs. \overline{CE} is the power control and should be used for a device selection. \overline{OE} is the output control and should be used to gate data to the output pins if a device is selected.

Address access time (t_{ACC}) is equal to the delay from stable addresses to valid output data. The chip enable access time (t_{CE}) is the delay from stable addresses and stable \overline{CE} to valid data at the output pins. The output enable access time is the delay from the falling edge of \overline{OE} to valid data at the output pins. (Assuming the addresses have been stable for at least $t_{ACC}-t_{OE}$ time.) When reading out a data without changing addresses after power-up, it is necessary to input hardware reset or change \overline{CE} pin from "H" or "L"

Standby Mode

There are two ways to implement the standby mode on the MBM29LV800TA/BA devices, one using both the \overline{CE} and \overline{RESET} pins; the other via the \overline{RESET} pin only.

When using both pins, a CMOS standby mode is achieved with \overline{CE} and \overline{RESET} inputs both held at $V_{CC} \pm 0.3$ V. Under this condition the current consumed is less than 5 μ A. The device can be read with standard access time (t_{CE}) from either of these standby modes. During Embedded Algorithm operation, V_{CC} active current (I_{CC2}) is required even \overline{CE} = "H".

When using the \overline{RESET} pin only, a CMOS standby mode is achieved with \overline{RESET} input held at $V_{SS} \pm 0.3$ V (\overline{CE} = "H" or "L"). Under this condition the current is consumed is less than 5 μ A. Once the \overline{RESET} pin is taken high, the device requires t_{RH} of wake up time before outputs are valid for read access.

In the standby mode the outputs are in the high impedance state, independent of the \overline{OE} input.

Automatic Sleep Mode

There is a function called automatic sleep mode to restrain power consumption during read-out of MBM29LV800TA/800BA data. This mode can be used effectively with an application requested low power consumption such as handy terminals.

To activate this mode, MBM29LV800TA/800BA automatically switch themselves to low power mode when MBM29LV800TA/800BA addresses remain stably during access time of 150 ns. It is not necessary to control \overline{CE} , \overline{WE} , and \overline{OE} on the mode. Under the mode, the current consumed is typically 1 μ A (CMOS Level).

Since the data are latched during this mode, the data are read-out continuously. If the addresses are changed, the mode is canceled automatically and MBM29LV800TA/800BA read-out the data for changed addresses.

Output Disable

With the \overline{OE} input at a logic high level (V_{IH}), output from the devices are disabled. This will cause the output pins to be in a high impedance state.

Autoselect

The autoselect mode allows the reading out of a binary code from the devices and will identify its manufacturer and type. This mode is intended for use by programming equipment for the purpose of automatically matching the devices to be programmed with its corresponding programming algorithm. This mode is functional over the entire temperature range of the devices.

To activate this mode, the programming equipment must force V_{ID} (11.5 V to 12.5 V) on address pin A_9 . Two identifier bytes may then be sequenced from the devices outputs by toggling address A_0 from V_{IL} to V_{IH} . All addresses are DON'T CARES except A_0 , A_1 , A_6 , and A_{-1} . (See Table 4.1.)

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The manufacturer and device codes may also be read via the command register, for instances when the MBM29LV800TA/BA are erased or programmed in a system without access to high voltage on the A₉ pin. The command sequence is illustrated in Table 7. (Refer to Autoselect Command section.)

Byte 0 (A₀ = V_{IL}) represents the manufacturer's code (Fujitsu = 04H) and (A₀ = V_{IH}) represents the device identifier code (MBM29LV800TA = DAH and MBM29LV800BA = 5BH for ×8 mode; MBM29LV800TA = 22DAH and MBM29LV800BA = 225BH for ×16 mode). These two bytes/words are given in the tables 4.1 and 4.2. All identifiers for manufactures and device will exhibit odd parity with DQ₇ defined as the parity bit. In order to read the proper device codes when executing the autoselect, A₁ must be V_{IL}. (See Tables 4.1 and 4.2.)

Table 4.1 MBM29LV800TA/800BA Sector Protection Verify Autoselect Codes

Type			A ₁₂ to A ₁₈	A ₆	A ₁	A ₀	A ₋₁ ^{*1}	Code (HEX)
Manufacture's Code			X	V _{IL}	V _{IL}	V _{IL}	V _{IL}	04H
Device Code	MBM29LV800TA	Byte	X	V _{IL}	V _{IL}	V _{IH}	V _{IL}	DAH
		Word					X	22DAH
	MBM29LV800BA	Byte	X	V _{IL}	V _{IL}	V _{IH}	V _{IL}	5BH
		Word					X	225BH
Sector Protection			Sector Addresses	V _{IL}	V _{IH}	V _{IL}	V _{IL}	01H ^{*2}

*1: A₋₁ is for Byte mode.

*2: Outputs 01H at protected sector addresses and outputs 00H at unprotected sector addresses.

Table 4.2 Expanded Autoselect Code Table

Type			Code	DQ ₁₅	DQ ₁₄	DQ ₁₃	DQ ₁₂	DQ ₁₁	DQ ₁₀	DQ ₉	DQ ₈	DQ ₇	DQ ₆	DQ ₅	DQ ₄	DQ ₃	DQ ₂	DQ ₁	DQ ₀
Manufacturer's Code			04H	A ₋₁ /0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	0
Device Code	MBM29LV800TA	(B)	DAH	A ₋₁	HI-Z	HI-Z	HI-Z	HI-Z	HI-Z	HI-Z	HI-Z	1	1	0	1	1	0	1	0
		(W)	22DAH	0	0	1	0	0	0	1	0	1	1	0	1	1	0	1	0
	MBM29LV800BA	(B)	5BH	A ₋₁	HI-Z	HI-Z	HI-Z	HI-Z	HI-Z	HI-Z	HI-Z	0	1	0	1	1	0	1	1
		(W)	225BH	0	0	1	0	0	0	1	0	0	1	0	1	1	0	1	1
Sector Protection			01H	A ₋₁ /0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1

(B): Byte mode

(W): Word mode

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Write

Device erasure and programming are accomplished via the command register. The contents of the register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device.

The command register itself does not occupy any addressable memory location. The register is a latch used to store the commands, along with the address and data information needed to execute the command. The command register is written by bringing \overline{WE} to V_{IL} , while \overline{CE} is at V_{IL} and \overline{OE} is at V_{IH} . Addresses are latched on the falling edge of \overline{WE} or \overline{CE} , whichever happens later; while data is latched on the rising edge of \overline{WE} or \overline{CE} , whichever happens first. Standard microprocessor write timings are used.

Refer to AC Write Characteristics and the Erase/Programming Waveforms for specific timing parameters.

Sector Protection

The MBM29LV800TA/BA feature hardware sector protection. This feature will disable both program and erase operations in any number of sectors (0 through 18). The sector protection feature is enabled using programming equipment at the user's site. The devices are shipped with all sectors unprotected. Alternatively, Fujitsu may program and protect sectors in the factory prior to shipping the device.

To activate this mode, the programming equipment must force V_{ID} on address pin A_9 and control pin \overline{OE} , (suggest $V_{ID} = 11.5\text{ V}$), $\overline{CE} = V_{IL}$, and $A_6 = V_{IL}$. The sector addresses (A_{18} , A_{17} , A_{16} , A_{15} , A_{14} , A_{13} , and A_{12}) should be set to the sector to be protected. Tables 5 and 6 define the sector address for each of the nineteen (19) individual sectors. Programming of the protection circuitry begins on the falling edge of the \overline{WE} pulse and is terminated with the rising edge of the same. Sector addresses must be held constant during the \overline{WE} pulse. See Figures 16 and 24 for sector protection waveforms and algorithm.

To verify programming of the protection circuitry, the programming equipment must force V_{ID} on address pin A_9 with \overline{CE} and \overline{OE} at V_{IL} and \overline{WE} at V_{IH} . Scanning the sector addresses (A_{18} , A_{17} , A_{16} , A_{15} , A_{14} , A_{13} , and A_{12}) while (A_6 , A_1 , A_0) = (0, 1, 0) will produce a logical "1" code at device output DQ_0 for a protected sector. Otherwise the devices will read 00H for unprotected sector. In this mode, the lower order addresses, except for A_0 , A_1 , and A_6 are DON'T CARES. Address locations with $A_1 = V_{IL}$ are reserved for Autoselect manufacturer and device codes. A_{-1} requires to apply to V_{IL} on byte mode.

It is also possible to determine if a sector is protected in the system by writing an Autoselect command. Performing a read operation at the address location XX02H, where the higher order addresses (A_{18} , A_{17} , A_{16} , A_{15} , A_{14} , A_{13} , and A_{12}) are the desired sector address will produce a logical "1" at DQ_0 for a protected sector. See Tables 4.1 and 4.2 for Autoselect codes.

Temporary Sector Unprotection

This feature allows temporary unprotection of previously protected sectors of the MBM29LV800TA/BA devices in order to change data. The Sector Unprotection mode is activated by setting the **RESET** pin to high voltage (12 V). During this mode, formerly protected sectors can be programmed or erased by selecting the sector addresses. Once the 12 V is taken away from the **RESET** pin, all the previously protected sectors will be protected again. See Figures 17 and 25.

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RESET

Hardware Reset

The MBM29LV800TA/BA devices may be reset by driving the **RESET** pin to V_{IL} . The **RESET** pin has a pulse requirement and has to be kept low (V_{IL}) for at least 500 ns in order to properly reset the internal state machine. Any operation in the process of being executed will be terminated and the internal state machine will be reset to the read mode 20 μ s after the **RESET** pin is driven low. Furthermore, once the **RESET** pin goes high, the devices require an additional t_{RH} before it will allow read access. When the **RESET** pin is low, the devices will be in the standby mode for the duration of the pulse and all the data output pins will be tri-stated. If a hardware reset occurs during a program or erase operation, the data at that particular location will be corrupted. Please note that the RY/BY output signal should be ignored during the **RESET** pulse. See Figure 12 for the timing diagram. Refer to Temporary Sector Unprotection for additional functionality.

If hardware reset occurs during Embedded Erase Algorithm, there is a possibility that the erasing sector(s) cannot be used.

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Table 5 Sector Address Tables (MBM29LV800TA)

Sector Address	A ₁₈	A ₁₇	A ₁₆	A ₁₅	A ₁₄	A ₁₃	A ₁₂	Address Range (×8)	Address Range (×16)
SA0	0	0	0	0	X	X	X	00000H to 0FFFFH	00000H to 07FFFFH
SA1	0	0	0	1	X	X	X	10000H to 1FFFFH	08000H to 0FFFFH
SA2	0	0	1	0	X	X	X	20000H to 2FFFFH	10000H to 17FFFFH
SA3	0	0	1	1	X	X	X	30000H to 3FFFFH	18000H to 1FFFFH
SA4	0	1	0	0	X	X	X	40000H to 4FFFFH	20000H to 27FFFFH
SA5	0	1	0	1	X	X	X	50000H to 5FFFFH	28000H to 2FFFFH
SA6	0	1	1	0	X	X	X	60000H to 6FFFFH	30000H to 37FFFFH
SA7	0	1	1	1	X	X	X	70000H to 7FFFFH	38000H to 3FFFFH
SA8	1	0	0	0	X	X	X	80000H to 8FFFFH	40000H to 47FFFFH
SA9	1	0	0	1	X	X	X	90000H to 9FFFFH	48000H to 4FFFFH
SA10	1	0	1	0	X	X	X	A0000H to AFFFFH	50000H to 57FFFFH
SA11	1	0	1	1	X	X	X	B0000H to BFFFFH	58000H to 5FFFFH
SA12	1	1	0	0	X	X	X	C0000H to CFFFFH	60000H to 67FFFFH
SA13	1	1	0	1	X	X	X	D0000H to DFFFFH	68000H to 6FFFFH
SA14	1	1	1	0	X	X	X	E0000H to EFFFFH	70000H to 77FFFFH
SA15	1	1	1	1	0	X	X	F0000H to F7FFFFH	78000H to 7BFFFFH
SA16	1	1	1	1	1	0	0	F8000H to F9FFFFH	7C000H to 7CFFFFH
SA17	1	1	1	1	1	0	1	FA000H to FBFFFFH	7D000H to 7DFFFFH
SA18	1	1	1	1	1	1	X	FC000H to FFFFFH	7E000H to 7FFFFH

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Table 6 Sector Address Tables (MBM29LV800BA)

Sector Address	A ₁₈	A ₁₇	A ₁₆	A ₁₅	A ₁₄	A ₁₃	A ₁₂	Address Range (×8)	Address Range (×16)
SA0	0	0	0	0	0	0	X	00000H to 03FFFFH	00000H to 01FFFFH
SA1	0	0	0	0	0	1	0	04000H to 05FFFFH	02000H to 02FFFFH
SA2	0	0	0	0	0	1	1	06000H to 07FFFFH	03000H to 03FFFFH
SA3	0	0	0	0	1	X	X	08000H to 0FFFFH	04000H to 07FFFFH
SA4	0	0	0	1	X	X	X	10000H to 1FFFFH	08000H to 0FFFFH
SA5	0	0	1	0	X	X	X	20000H to 2FFFFH	10000H to 17FFFFH
SA6	0	0	1	1	X	X	X	30000H to 3FFFFH	18000H to 1FFFFH
SA7	0	1	0	0	X	X	X	40000H to 4FFFFH	20000H to 27FFFFH
SA8	0	1	0	1	X	X	X	50000H to 5FFFFH	28000H to 2FFFFH
SA9	0	1	1	0	X	X	X	60000H to 6FFFFH	30000H to 37FFFFH
SA10	0	1	1	1	X	X	X	70000H to 7FFFFH	38000H to 3FFFFH
SA11	1	0	0	0	X	X	X	80000H to 8FFFFH	40000H to 47FFFFH
SA12	1	0	0	1	X	X	X	90000H to 9FFFFH	48000H to 4FFFFH
SA13	1	0	1	0	X	X	X	A0000H to AFFFFH	50000H to 57FFFFH
SA14	1	0	1	1	X	X	X	B0000H to BFFFFH	58000H to 5FFFFH
SA15	1	1	0	0	X	X	X	C0000H to CFFFFH	60000H to 67FFFFH
SA16	1	1	0	1	X	X	X	D0000H to DFFFFH	68000H to 6FFFFH
SA17	1	1	1	0	X	X	X	E0000H to EFFFFH	70000H to 77FFFFH
SA18	1	1	1	1	X	X	X	F0000H to FFFFFH	78000H to 7FFFFH

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Table 7 MBM29LV800TA/800BA Standard Command Definitions

Command Sequence		Bus Write Cycles Req'd	First Bus Write Cycle		Second Bus Write Cycle		Third Bus Write Cycle		Fourth Bus Read/Write Cycle		Fifth Bus Write Cycle		Sixth Bus Write Cycle	
			Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data	Addr.	Data
Read/Reset	Word	1	XXXH	F0H	—	—	—	—	—	—	—	—	—	—
	Byte													
Read/Reset	Word	3	555H	AAH	2AAH	55H	555H	F0H	RA	RD	—	—	—	—
	Byte		AAAH		555H		AAAH							
Autoselect	Word	3	555H	AAH	2AAH	55H	555H	90H	—	—	—	—	—	—
	Byte		AAAH		555H		AAAH							
Program	Word	4	555H	AAH	2AAH	55H	555H	A0H	PA	PD	—	—	—	—
	Byte		AAAH		555H		AAAH							
Chip Erase	Word	6	555H	AAH	2AAH	55H	555H	80H	555H	AAH	2AAH	55H	555H	10H
	Byte		AAAH		555H		AAAH		AAAH		555H			
Sector Erase	Word	6	555H	AAH	2AAH	55H	555H	80H	555H	AAH	2AAH	55H	SA	30H
	Byte		AAAH		555H		AAAH		AAAH		555H			
Sector Erase Suspend			Erase can be suspended during sector erase with Addr. ("H" or "L"). Data (B0H)											
Sector Erase Resume			Erase can be resumed after suspend with Addr. ("H" or "L"). Data (30H)											

- Notes:**
- Address bits A₁₁ to A₁₈ = X = "H" or "L" for all address commands except or Program Address (PA) and Sector Address (SA)
 - Bus operations are defined in Tables 2 and 3.
 - RA = Address of the memory location to be read
PA = Address of the memory location to be programmed
Addresses are latched on the falling edge of the \overline{WE} pulse.
SA = Address of the sector to be erased. The combination of A₁₈, A₁₇, A₁₆, A₁₅, A₁₄, A₁₃, and A₁₂ will uniquely select any sector.
 - RD = Data read from location RA during read operation.
PD = Data to be programmed at location PA. Data is latched on the falling edge of \overline{WE} .
 - The system should generate the following address patterns:
Word Mode: 555H or 2AAH to addresses A₀ to A₁₀
Byte Mode: AA AH or 555H to addresses A₋₁ and A₀ to A₁₀
 - Both Read/Reset commands are functionally equivalent, resetting the device to the read mode.

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Table 8 MBM29LV800TA/BA Extended Command Definitions

Command Sequence		Bus Write Cycles Req'd	First Bus Write Cycle		Second Bus Write Cycle		Third Bus Write Cycle		Fourth Bus Read Cycle	
			Addr	Data	Addr	Data	Addr	Data	Addr	Data
Set to Fast Mode	Word	3	555H	AAH	2AAH	55H	555H	20H	—	—
	Byte		AAAH		555H		AAAH			
Fast Program (Note)	Word	2	XXXH	A0H	PA	PD	—	—	—	—
	Byte		XXXH							
Reset from Fast Mode (Note)	Word	2	XXXH	90H	XXXH	F0H	—	—	—	—
	Byte		XXXH		XXXH					
Extended Sector Protect	Word	4	XXXH	60H	SPA	60H	SPA	40H	SPA	SD
	Byte									

SPA : Sector address to be protected. Set sector address (SA) and (A₆, A₁, A₀) = (0, 1, 0).

SD : Sector protection verify data. Output 01H at protected sector addresses and output 00H at unprotected sector addresses.

Note: This command is valid while Fast Mode.

Command Definitions

Device operations are selected by writing specific address and data sequences into the command register. Writing incorrect address and data values or writing them in the improper sequence will reset the devices to the read mode. Table 7 defines the valid register command sequences. Note that the Erase Suspend (B0H) and Erase Resume (30H) commands are valid only while the Sector Erase operation is in progress. Moreover both Read/Reset commands are functionally equivalent, resetting the device to the read mode. Please note that commands are always written at DQ₀ to DQ₇ and DQ₈ to DQ₁₅ bits are ignored.

Read/Reset Command

In order to return from Autoselect mode or Exceeded Timing Limits (DQ₅ = 1) to read/reset mode, the read/reset operation is initiated by writing the Read/Reset command sequence into the command register. Microprocessor read cycles retrieve array data from the memory. The devices remain enabled for reads until the command register contents are altered.

The devices will automatically power-up in the read/reset state. In this case, a command sequence is not required to read data. Standard microprocessor read cycles will retrieve array data. This default value ensures that no spurious alteration of the memory content occurs during the power transition. Refer to the AC Read Characteristics and Waveforms for the specific timing parameters.

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Autoselect Command

Flash memories are intended for use in applications where the local CPU alters memory contents. As such, manufacture and device codes must be accessible while the devices reside in the target system. PROM programmers typically access the signature codes by raising A_9 to a high voltage. However, multiplexing high voltage onto the address lines is not generally desired system design practice.

The device contains an Autoselect command operation to supplement traditional PROM programming methodology. The operation is initiated by writing the Autoselect command sequence into the command register. Following the command write, a read cycle from address XX00H retrieves the manufacture code of 04H. A read cycle from address XX01H for $\times 16$ (XX02H for $\times 8$) returns the device code (MBM29LV800TA = DAH and MBM29LV800BA = 5BH for $\times 8$ mode; MBM29LV800TA = 22DAH and MBM29LV800BA = 225BH for $\times 16$ mode). (See Tables 4.1 and 4.2.) All manufacturer and device codes will exhibit odd parity with DQ_7 defined as the parity bit. Sector state (protection or unprotection) will be informed by address XX02H for $\times 16$ (XX04H for $\times 8$). Scanning the sector addresses (A_{18} , A_{17} , A_{16} , A_{15} , A_{14} , A_{13} , and A_{12}) while (A_6 , A_1 , A_0) = (0, 1, 0) will produce a logical "1" at device output DQ_0 for a protected sector. The programming verification should be performed margin mode on the protected sector. (See Tables 2 and 3.)

To terminate the operation, it is necessary to write the Read/Reset command sequence into the register, and also to write the Autoselect command during the operation, execute it after writing Read/Reset command sequence.

Byte/Word Programming

The devices are programmed on a byte-by-byte (or word-by-word) basis. Programming is a four bus cycle operation. There are two "unlock" write cycles. These are followed by the program set-up command and data write cycles. Addresses are latched on the falling edge of \overline{CE} or \overline{WE} , whichever happens later and the data is latched on the rising edge of \overline{CE} or \overline{WE} , whichever happens first. The rising edge of \overline{CE} or \overline{WE} (whichever happens first) begins programming. Upon executing the Embedded Program Algorithm command sequence, the system is not required to provide further controls or timings. The device will automatically provide adequate internally generated program pulses and verify the programmed cell margin.

The automatic programming operation is completed when the data on DQ_7 is equivalent to data written to this bit at which time the devices return to the read mode and addresses are no longer latched. (See Table 9, Hardware Sequence Flags.) Therefore, the devices require that a valid address to the devices be supplied by the system at this particular instance of time. Hence, Data Polling must be performed at the memory location which is being programmed.

Any commands written to the chip during this period will be ignored. If hardware reset occurs during the programming operation, it is impossible to guarantee the data are being written.

Programming is allowed in any sequence and across sector boundaries. Beware that a data "0" cannot be programmed back to a "1". Attempting to do so may either hang up the device or result in an apparent success according to the data polling algorithm but a read from read/reset mode will show that the data is still "0". Only erase operations can convert "0"s to "1"s.

Figure 20 illustrates the Embedded Program™ Algorithm using typical command strings and bus operations.

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Chip Erase

Chip erase is a six bus cycle operation. There are two “unlock” write cycles. These are followed by writing the “set-up” command. Two more “unlock” write cycles are then followed by the chip erase command.

Chip erase does not require the user to program the device prior to erase. Upon executing the Embedded Erase Algorithm command sequence the devices will automatically program and verify the entire memory for an all zero data pattern prior to electrical erase (Preprogram function). The system is not required to provide any controls or timings during these operations.

The automatic erase begins on the rising edge of the last \overline{WE} pulse in the command sequence and terminates when the data on DQ₇ is “1” (See Write Operation Status section.) at which time the device returns to read the mode.

Chip Erase Time; Sector Erase Time × All sectors + Chip Program Time (Preprogramming)

Figure 21 illustrates the Embedded Erase™ Algorithm using typical command strings and bus operations.

Sector Erase

Sector erase is a six bus cycle operation. There are two “unlock” write cycles. These are followed by writing the “set-up” command. Two more “unlock” write cycles are then followed by the Sector Erase command. The sector address (any address location within the desired sector) is latched on the falling edge of \overline{WE} , while the command (Data=30H) is latched on the rising edge of \overline{WE} . After time-out of 50 μ s from the rising edge of the last sector erase command, the sector erase operation will begin.

Multiple sectors may be erased concurrently by writing the six bus cycle operations on Table 7. This sequence is followed with writes of the Sector Erase command to addresses in other sectors desired to be concurrently erased. The time between writes must be less than 50 μ s otherwise that command will not be accepted and erasure will start. It is recommended that processor interrupts be disabled during this time to guarantee this condition. The interrupts can be re-enabled after the last Sector Erase command is written. A time-out of 50 μ s from the rising edge of the last \overline{WE} will initiate the execution of the Sector Erase command(s). If another falling edge of the \overline{WE} occurs within the 50 μ s time-out window the timer is reset. (Monitor DQ₃ to determine if the sector erase timer window is still open, see section DQ₃, Sector Erase Timer.) Any command other than Sector Erase or Erase Suspend during this time-out period will reset the devices to the read mode, ignoring the previous command string. Resetting the devices once execution has begun will corrupt the data in the sector. In that case, restart the erase on those sectors and allow them to complete. (Refer to the Write Operation Status section for Sector Erase Timer operation.) Loading the sector erase buffer may be done in any sequence and with any number of sectors (0 to 18).

Sector erase does not require the user to program the devices prior to erase. The devices automatically program all memory locations in the sector(s) to be erased prior to electrical erase (Preprogram function). When erasing a sector or sectors the remaining unselected sectors are not affected. The system is not required to provide any controls or timings during these operations.

The automatic sector erase begins after the 50 μ s time out from the rising edge of the \overline{WE} pulse for the last sector erase command pulse and terminates when the data on DQ₇ is “1” (See Write Operation Status section.) at which time the devices return to the read mode. Data polling must be performed at an address within any of the sectors being erased. Multiple Sector Erase Time; [Sector Erase Time + Sector Program Time (Preprogramming)] × Number of Sector Erase

Figure 21 illustrates the Embedded Erase™ Algorithm using typical command strings and bus operations.

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Erase Suspend

The Erase Suspend command allows the user to interrupt a Sector Erase operation and then perform data reads from or programs to a sector not being erased. This command is applicable ONLY during the Sector Erase operation which includes the time-out period for sector erase. The Erase Suspend command will be ignored if written during the Chip Erase operation or Embedded Program Algorithm. Writing the Erase Suspend command during the Sector Erase time-out results in immediate termination of the time-out period and suspension of the erase operation.

Writing the Erase Resume command resumes the erase operation. The addresses are DON'T CARES when writing the Erase Suspend or Erase Resume command.

When the Erase Suspend command is written during the Sector Erase operation, the device will take a maximum of 20 μ s to suspend the erase operation. When the devices have entered the erase-suspended mode, the RY/ $\overline{\text{BY}}$ output pin and the DQ₇ bit will be at logic "1", and DQ₆ will stop toggling. The user must use the address of the erasing sector for reading DQ₆ and DQ₇ to determine if the erase operation has been suspended. Further writes of the Erase Suspend command are ignored.

When the erase operation has been suspended, the devices default to the erase-suspend-read mode. Reading data in this mode is the same as reading from the standard read mode except that the data must be read from sectors that have not been erase-suspended. Successively reading from the erase-suspended sector while the device is in the erase-suspend-read mode will cause DQ₂ to toggle. (See the section on DQ₂.)

After entering the erase-suspend-read mode, the user can program the device by writing the appropriate command sequence for Program. This program mode is known as the erase-suspend-program mode. Again, programming in this mode is the same as programming in the regular Program mode except that the data must be programmed to sectors that are not erase-suspended. Successively reading from the erase-suspended sector while the devices are in the erase-suspend-program mode will cause DQ₂ to toggle. The end of the erase-suspended Program operation is detected by the RY/ $\overline{\text{BY}}$ output pin, $\overline{\text{Data}}$ polling of DQ₇, or by the Toggle Bit I (DQ₆) which is the same as the regular Program operation. Note that DQ₇ must be read from the Program address while DQ₆ can be read from any address.

To resume the operation of Sector Erase, the Resume command (30H) should be written. Any further writes of the Resume command at this point will be ignored. Another Erase Suspend command can be written after the chip has resumed erasing.

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Extended Command

(1) Fast Mode

MBM29LV800TA/BA has Fast Mode function. This mode dispenses with the initial two unlock cycles required in the standard program command sequence by writing Fast Mode command into the command register. In this mode, the required bus cycle for programming is two cycles instead of four bus cycles in standard program command. (Do not write erase command in this mode.) The read operation is also executed after exiting this mode. To exit this mode, it is necessary to write Fast Mode Reset command into the command register. (Refer to the Figure 27 Extended algorithm.) The V_{CC} active current is required even $\overline{CE} = V_{IH}$ during Fast Mode.

(2) Fast Programming

During Fast Mode, the programming can be executed with two bus cycles operation. The Embedded Program Algorithm is executed by writing program set-up command (A0H) and data write cycles (PA/PD). (Refer to the Figure 27 Extended algorithm.)

(3) Extended Sector Protection

In addition to normal sector protection, the MBM29LV800TA/BA has Extended Sector Protection as extended function. This function enable to protect sector by forcing V_{ID} on **RESET** pin and write a command sequence. Unlike conventional procedure, it is not necessary to force V_{ID} and control timing for control pins. The only **RESET** pin requires V_{ID} for sector protection in this mode. The extended sector protect requires V_{ID} on **RESET** pin. With this condition, the operation is initiated by writing the set-up command (60H) into the command register. Then, the sector addresses pins ($A_{18}, A_{17}, A_{16}, A_{15}, A_{14}, A_{13}$ and A_{12}) and (A_6, A_1, A_0) = (0, 1, 0) should be set to the sector to be protected (recommend to set V_{IL} for the other addresses pins), and write extended sector protect command (60H). A sector is typically protected in 150 μs . To verify programming of the protection circuitry, the sector addresses pins ($A_{18}, A_{17}, A_{16}, A_{15}, A_{14}, A_{13}$ and A_{12}) and (A_6, A_1, A_0) = (0, 1, 0) should be set and write a command (40H). Following the command write, a logical "1" at device output DQ_0 will produce for protected sector in the read operation. If the output data is logical "0", please repeat to write extended sector protect command (60H) again. To terminate the operation, it is necessary to set **RESET** pin to V_{IH} .

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Write Operation Status

Table 9 Hardware Sequence Flags

Status			DQ ₇	DQ ₆	DQ ₅	DQ ₃	DQ ₂
In Progress	Embedded Program Algorithm		$\overline{\text{DQ}}_7$	Toggle	0	0	1
	Embedded Erase Algorithm		0	Toggle	0	1	Toggle
	Erase Suspended Mode	Erase Suspend Read (Erase Suspended Sector)	1	1	0	0	Toggle
		Erase Suspend Read (Non-Erase Suspended Sector)	Data	Data	Data	Data	Data
		Erase Suspend Program (Non-Erase Suspended Sector)	$\overline{\text{DQ}}_7$	Toggle (Note 1)	0	0	1 (Note 2)
Exceeded Time Limits	Embedded Program Algorithm		$\overline{\text{DQ}}_7$	Toggle	1	0	1
	Embedded Erase Algorithm		0	Toggle	1	1	N/A
	Erase Suspended Mode	Erase Suspend Program (Non-Erase Suspended Sector)	$\overline{\text{DQ}}_7$	Toggle	1	0	N/A

- Notes:**
1. Performing successive read operations from any address will cause DQ₆ to toggle.
 2. Reading the byte address being programmed while in the erase-suspend program mode will indicate logic “1” at the DQ₂ bit. However, successive reads from the erase-suspended sector will cause DQ₂ to toggle.
 3. DQ₀ and DQ₁ are reserve pins for future use.
 4. DQ₄ is Fujitsu internal use only.

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DQ₇

Data Polling

The MBM29LV800TA/BA devices feature $\overline{\text{Data}}$ Polling as a method to indicate to the host that the Embedded Algorithms are in progress or completed. During the Embedded Program Algorithm an attempt to read the devices will produce the complement of the data last written to DQ₇. Upon completion of the Embedded Program Algorithm, an attempt to read the device will produce the true data last written to DQ₇. During the Embedded Erase Algorithm, an attempt to read the device will produce a “0” at the DQ₇ output. Upon completion of the Embedded Erase Algorithm an attempt to read the device will produce a “1” at the DQ₇ output. The flowchart for $\overline{\text{Data}}$ Polling (DQ₇) is shown in Figure 22.

For chip erase and sector erase, the $\overline{\text{Data}}$ Polling is valid after the rising edge of the sixth $\overline{\text{WE}}$ pulse in the six write pulse sequence. $\overline{\text{Data}}$ Polling must be performed at sector address within any of the sectors being erased and not a protected sector. Otherwise, the status may not be valid. Once the Embedded Algorithm operation is close to being completed, the MBM29LV800TA/BA data pins (DQ₇) may change asynchronously while the output enable ($\overline{\text{OE}}$) is asserted low. This means that the devices are driving status information on DQ₇ at one instant of time and then that byte's valid data at the next instant of time. Depending on when the system samples the DQ₇ output, it may read the status or valid data. Even if the device has completed the Embedded Algorithm operation and DQ₇ has a valid data, the data outputs on DQ₀ to DQ₆ may be still invalid. The valid data on DQ₀ to DQ₇ will be read on the successive read attempts.

The $\overline{\text{Data}}$ Polling feature is only active during the Embedded Programming Algorithm, Embedded Erase Algorithm or sector erase time-out. (See Table 9.)

See Figure 9 for the $\overline{\text{Data}}$ Polling timing specifications and diagrams.

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DQ₆

Toggle Bit I

The MBM29LV800TA/BA also feature the “Toggle Bit I” as a method to indicate to the host system that the Embedded Algorithms are in progress or completed.

During an Embedded Program or Erase Algorithm cycle, successive attempts to read ($\overline{\text{OE}}$ toggling) data from the devices will result in DQ₆ toggling between one and zero. Once the Embedded Program or Erase Algorithm cycle is completed, DQ₆ will stop toggling and valid data will be read on the next successive attempts. During programming, the Toggle Bit I is valid after the rising edge of the fourth $\overline{\text{WE}}$ pulse in the four write pulse sequence. For chip erase and sector erase, the Toggle Bit I is valid after the rising edge of the sixth $\overline{\text{WE}}$ pulse in the six write pulse sequence. The Toggle Bit I is active during the sector time out.

In programming, if the sector being written to is protected, the toggle bit will toggle for about 2 μs and then stop toggling without the data having changed. In erase, the devices will erase all the selected sectors except for the ones that are protected. If all selected sectors are protected, the chip will toggle the toggle bit for about 100 μs and then drop back into read mode, having changed none of the data.

Either $\overline{\text{CE}}$ or $\overline{\text{OE}}$ toggling will cause the DQ₆ to toggle. In addition, an Erase Suspend/Resume command will cause the DQ₆ to toggle.

See Figure 10 for the Toggle Bit I timing specifications and diagrams.

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DQ₅

Exceeded Timing Limits

DQ₅ will indicate if the program or erase time has exceeded the specified limits (internal pulse count). Under these conditions DQ₅ will produce a “1”. This is a failure condition which indicates that the program or erase cycle was not successfully completed. $\overline{\text{Data}}$ Polling is the only operating function of the devices under this condition. The $\overline{\text{CE}}$ circuit will partially power down the device under these conditions (to approximately 2 mA). The $\overline{\text{OE}}$ and $\overline{\text{WE}}$ pins will control the output disable functions as described in Tables 2 and 3.

The DQ₅ failure condition may also appear if a user tries to program a non blank location without erasing. In this case the devices lock out and never complete the Embedded Algorithm operation. Hence, the system never reads a valid data on DQ₇ bit and DQ₆ never stops toggling. Once the devices have exceeded timing limits, the DQ₅ bit will indicate a “1.” Please note that this is not a device failure condition since the devices were incorrectly used. If this occurs, reset the device with command sequence.

DQ₃

Sector Erase Timer

After the completion of the initial sector erase command sequence the sector erase time-out will begin. DQ₃ will remain low until the time-out is complete. $\overline{\text{Data}}$ Polling and Toggle Bit are valid after the initial sector erase command sequence.

If $\overline{\text{Data}}$ Polling or the Toggle Bit I indicates the device has been written with a valid erase command, DQ₃ may be used to determine if the sector erase timer window is still open. If DQ₃ is high (“1”) the internally controlled erase cycle has begun; attempts to write subsequent commands to the device will be ignored until the erase operation is completed as indicated by $\overline{\text{Data}}$ Polling or Toggle Bit I. If DQ₃ is low (“0”), the device will accept additional sector erase commands. To insure the command has been accepted, the system software should check the status of DQ₃ prior to and following each subsequent Sector Erase command. If DQ₃ were high on the second status check, the command may not have been accepted.

See Table 9: Hardware Sequence Flags.

DQ₂

Toggle Bit II

This toggle bit II, along with DQ₆, can be used to determine whether the devices are in the Embedded Erase Algorithm or in Erase Suspend.

Successive reads from the erasing sector will cause DQ₂ to toggle during the Embedded Erase Algorithm. If the devices are in the erase-suspended-read mode, successive reads from the erase-suspended sector will cause DQ₂ to toggle. When the devices are in the erase-suspended-program mode, successive reads from the byte address of the non-erase suspended sector will indicate a logic “1” at the DQ₂ bit.

DQ₆ is different from DQ₂ in that DQ₆ toggles only when the standard program or Erase, or Erase Suspend Program operation is in progress. The behavior of these two status bits, along with that of DQ₇, is summarized as follows:

For example, DQ₂ and DQ₆ can be used together to determine if the erase-suspend-read mode is in progress. (DQ₂ toggles while DQ₆ does not.) See also Table 9 and Figure 18.

Furthermore, DQ₂ can also be used to determine which sector is being erased. When the device is in the erase mode, DQ₂ toggles if this bit is read from an erasing sector.

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Mode	DQ ₇	DQ ₆	DQ ₂
Program	DQ ₇	Toggle	1
Erase	0	Toggle	Toggle
Erase-Suspend Read (Erase-Suspended Sector) (Note 1)	1	1	Toggle
Erase-Suspend Program	DQ ₇	Toggle (Note 1)	1 (Note 2)

Notes: 1. Performing successive read operations from any address will cause DQ₆ to toggle.
2. Reading the byte address being programmed while in the erase-suspend program mode will indicate logic “1” at the DQ₂ bit. However, successive reads from the erase-suspended sector will cause DQ₂ to toggle.

RY/BY

Ready/Busy

The MBM29LV800TA/BA provide a RY/BY open-drain output pin as a way to indicate to the host system that the Embedded Algorithms are either in progress or has been completed. If the output is low, the devices are busy with either a program or erase operation. If the output is high, the devices are ready to accept any read/write or erase operation. When the RY/BY pin is low, the devices will not accept any additional program or erase commands. If the MBM29LV800TA/BA are placed in an Erase Suspend mode, the RY/BY output will be high.

During programming, the RY/BY pin is driven low after the rising edge of the fourth WE pulse. During an erase operation, the RY/BY pin is driven low after the rising edge of the sixth WE pulse. The RY/BY pin will indicate a busy condition during the RESET pulse. Refer to Figure 11 and 12 for a detailed timing diagram. The RY/BY pin is pulled high in standby mode.

Since this is an open-drain output, RY/BY pins can be tied together in parallel with a pull-up resistor to V_{CC}.

Byte/Word Configuration

The BYTE pin selects the byte (8-bit) mode or word (16-bit) mode for the MBM29LV800TA/BA devices. When this pin is driven high, the devices operate in the word (16-bit) mode. The data is read and programmed at DQ₀ to DQ₁₅. When this pin is driven low, the devices operate in byte (8-bit) mode. Under this mode, the DQ_{15/A-1} pin becomes the lowest address bit and DQ₈ to DQ₁₄ bits are tri-stated. However, the command bus cycle is always an 8-bit operation and hence commands are written at DQ₀ to DQ₇ and the DQ₈ to DQ₁₅ bits are ignored. Refer to Figures 13, 14 and 15 for the timing diagram.

Data Protection

The MBM29LV800TA/BA are designed to offer protection against accidental erasure or programming caused by spurious system level signals that may exist during power transitions. During power up the devices automatically reset the internal state machine in the Read mode. Also, with its control register architecture, alteration of the memory contents only occurs after successful completion of specific multi-bus cycle command sequences.

The devices also incorporate several features to prevent inadvertent write cycles resulting from V_{CC} power-up and power-down transitions or system noise.

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Low V_{CC} Write Inhibit

To avoid initiation of a write cycle during V_{CC} power-up and power-down, a write cycle is locked out for V_{CC} less than 2.3 V (typically 2.4 V). If $V_{CC} < V_{LKO}$, the command register is disabled and all internal program/erase circuits are disabled. Under this condition the device will reset to the read mode. Subsequent writes will be ignored until the V_{CC} level is greater than V_{LKO} . It is the users responsibility to ensure that the control pins are logically correct to prevent unintentional writes when V_{CC} is above 2.3 V.

If Embedded Erase Algorithm is interrupted, there is possibility that the erasing sector(s) cannot be used.

Write Pulse “Glitch” Protection

Noise pulses of less than 5 ns (typical) on \overline{OE} , \overline{CE} , or \overline{WE} will not initiate a write cycle.

Logical Inhibit

Writing is inhibited by holding any one of $\overline{OE} = V_{IL}$, $\overline{CE} = V_{IH}$, or $\overline{WE} = V_{IH}$. To initiate a write cycle \overline{CE} and \overline{WE} must be a logical zero while \overline{OE} is a logical one.

Power-Up Write Inhibit

Power-up of the devices with $\overline{WE} = \overline{CE} = V_{IL}$ and $\overline{OE} = V_{IH}$ will not accept commands on the rising edge of \overline{WE} . The internal state machine is automatically reset to the read mode on power-up.

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■ ABSOLUTE MAXIMUM RATINGS

Storage Temperature	-55°C to +125°C
Ambient Temperature with Power Applied	-40°C to +85°C
Voltage with respect to Ground All pins except A ₉ , \overline{OE} , RESET (Note 1)	-0.5 V to V _{CC} +0.5 V
V _{CC} (Note 1)	-0.5 V to +5.5 V
A ₉ , \overline{OE} , and RESET (Note 2)	-0.5 V to +13.0 V

- Notes:** 1. Minimum DC voltage on input or I/O pins are -0.5 V. During voltage transitions, inputs may negative overshoot V_{SS} to -2.0 V for periods of up to 20 ns. Maximum DC voltage on output and I/O pins are V_{CC} +0.5 V. During voltage transitions, outputs may positive overshoot to V_{CC} +2.0 V for periods of up to 20 ns.
2. Minimum DC input voltage on A₉, \overline{OE} and RESET pins are -0.5 V. During voltage transitions, A₉, \overline{OE} and RESET pins may negative overshoot V_{SS} to -2.0 V for periods of up to 20 ns. Maximum DC input voltage on A₉, \overline{OE} and RESET pins are +13.0 V which may positive overshoot to 14.0 V for periods of up to 20 ns. Voltage difference between input voltage and supply voltage (V_{IN} - V_{CC}) do not exceed 9 V.

WARNING: Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

■ RECOMMENDED OPERATING RANGES

Ambient Temperature (T _A)	
Ambient Temperature for MBM29LV800TA/BA-90	-20°C to +70°C
Ambient Temperature for MBM29LV800TA/BA-12	-40°C to +85°C
V _{CC} Supply Voltages	+2.7 V to +3.6 V

Operating ranges define those limits between which the functionality of the devices are guaranteed.

WARNING: Recommended operating conditions are normal operating ranges for the semiconductor device. All the device's electrical characteristics are warranted when operated within these ranges.

Always use semiconductor devices within the recommended operating conditions. Operation outside these ranges may adversely affect reliability and could result in device failure.

No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their FUJITSU representative beforehand.

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■ MAXIMUM OVERSHOOT

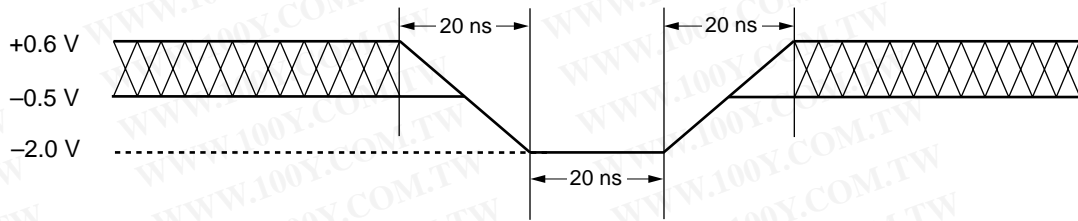


Figure 1 Maximum Negative Overshoot Waveform

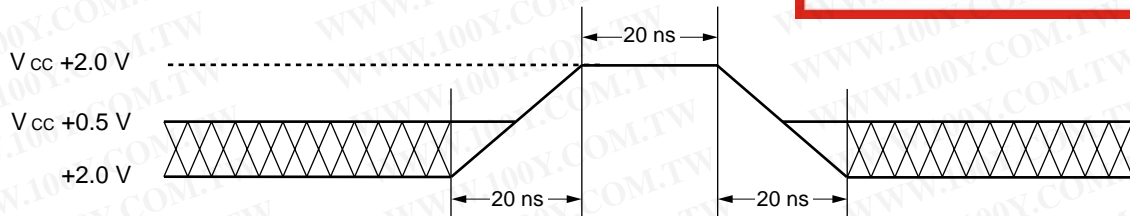
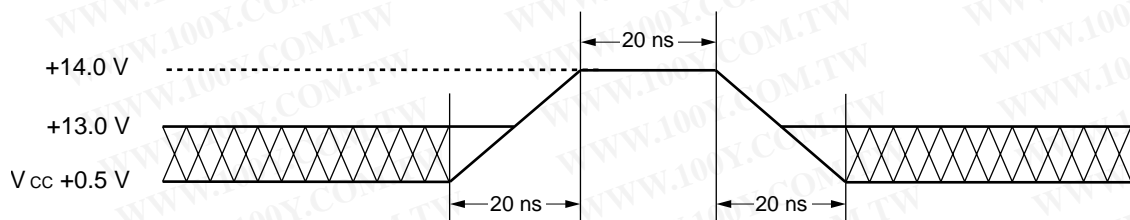


Figure 2 Maximum Positive Overshoot Waveform 1

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*: This waveform is applied for A_9 , \overline{OE} , and \overline{RESET} .

Figure 3 Maximum Positive Overshoot Waveform 2

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■ DC CHARACTERISTICS

Parameter Symbol	Parameter Description	Test Conditions		Min.	Max.	Unit
I _{LI}	Input Leakage Current	V _{IN} = V _{SS} to V _{CC} , V _{CC} = V _{CC} Max.		-1.0	+1.0	μA
I _{LO}	Output Leakage Current	V _{OUT} = V _{SS} to V _{CC} , V _{CC} = V _{CC} Max.		-1.0	+1.0	μA
I _{LIT}	A ₉ , OE, RESET Inputs Leakage Current	V _{CC} = V _{CC} Max. A ₉ , OE, RESET = 12.5 V		—	35	μA
I _{CC1}	V _{CC} Active Current (Note 1)	CE = V _{IL} , OE = V _{IH} , f=10 MHz	Byte	—	22	mA
			Word		25	
		CE = V _{IL} , OE = V _{IH} , f=5 MHz	Byte	—	12	mA
			Word		15	
I _{CC2}	V _{CC} Active Current (Note 2)	CE = V _{IL} , OE = V _{IH}		—	35	mA
I _{CC3}	V _{CC} Current (Standby)	V _{CC} = V _{CC} Max., CE = V _{CC} ± 0.3 V, RESET = V _{CC} ± 0.3 V		—	5	μA
I _{CC4}	V _{CC} Current (Standby, Reset)	V _{CC} = V _{CC} Max., RESET = V _{SS} ± 0.3 V		—	5	μA
I _{CC5}	V _{CC} Current (Automatic Sleep Mode) (Note 3)	V _{CC} = V _{CC} Max., CE = V _{SS} ± 0.3 V, RESET = V _{CC} ± 0.3 V V _{IN} = V _{CC} ± 0.3 V or V _{SS} ± 0.3 V		—	5	μA
V _{IL}	Input Low Level	—		-0.5	0.6	V
V _{IH}	Input High Level	—		2.0	V _{CC} +0.3	V
V _{ID}	Voltage for Autoselect and Sector Protection (A ₉ , OE, RESET) (Note 4)	—		11.5	12.5	V
V _{OL}	Output Low Voltage Level	I _{OL} = 4.0 mA, V _{CC} = V _{CC} Min.		—	0.45	V
V _{OH1}	Output High Voltage Level	I _{OH} = -2.0 mA, V _{CC} = V _{CC} Min.		2.4	—	V
V _{OH2}		I _{OH} = -100 μA, V _{CC} = V _{CC} Min.		V _{CC} -0.4	—	V
V _{LKO}	Low V _{CC} Lock-Out Voltage	—		2.3	2.5	V

- Notes:**
1. The I_{CC} current listed includes both the DC operating current and the frequency dependent component (at 10 MHz).
 2. I_{CC} active while Embedded Algorithm (program or erase) is in progress.
 3. Automatic sleep mode enables the low power mode when address remain stable for 150 ns.
 4. (V_{ID} - V_{CC}) do not exceed 9 V.

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■ AC CHARACTERISTICS

• Read Only Operations Characteristics

Parameter Symbols		Description	Test Setup		-90 (Note)	-12 (Note)	Unit
JEDEC	Standard						
t_{AVAV}	t_{RC}	Read Cycle Time	—	Min.	90	120	ns
t_{AVQV}	t_{ACC}	Address to Output Delay	$\overline{CE} = V_{IL}$ $\overline{OE} = V_{IL}$	Max.	90	120	ns
t_{ELQV}	t_{CE}	Chip Enable to Output Delay	$\overline{OE} = V_{IL}$	Max.	90	120	ns
t_{GLQV}	t_{OE}	Output Enable to Output Delay	—	Max.	35	50	ns
t_{EHQZ}	t_{DF}	Chip Enable to Output High-Z	—	Max.	30	30	ns
t_{GHQZ}	t_{DF}	Output Enable to Output High-Z	—	Max.	30	30	ns
t_{AXQX}	t_{OH}	Output Hold Time From Addresses, \overline{CE} or \overline{OE} , Whichever Occurs First	—	Min.	0	0	ns
—	t_{READY}	RESET Pin Low to Read Mode	—	Max.	20	20	μs
—	t_{ELFL} t_{ELFH}	\overline{CE} or BYTE Switching Low or High	—	Max.	5	5	ns

Note: Test Conditions:

Output Load: 1 TTL gate and 30 pF (MBM29LV800TA/BA-90)
1 TTL gate and 100 pF (MBM29LV800TA/BA-12)

Input rise and fall times: 5 ns

Input pulse levels: 0.0 V to 3.0 V

Timing measurement reference level

Input: 1.5 V

Output: 1.5 V

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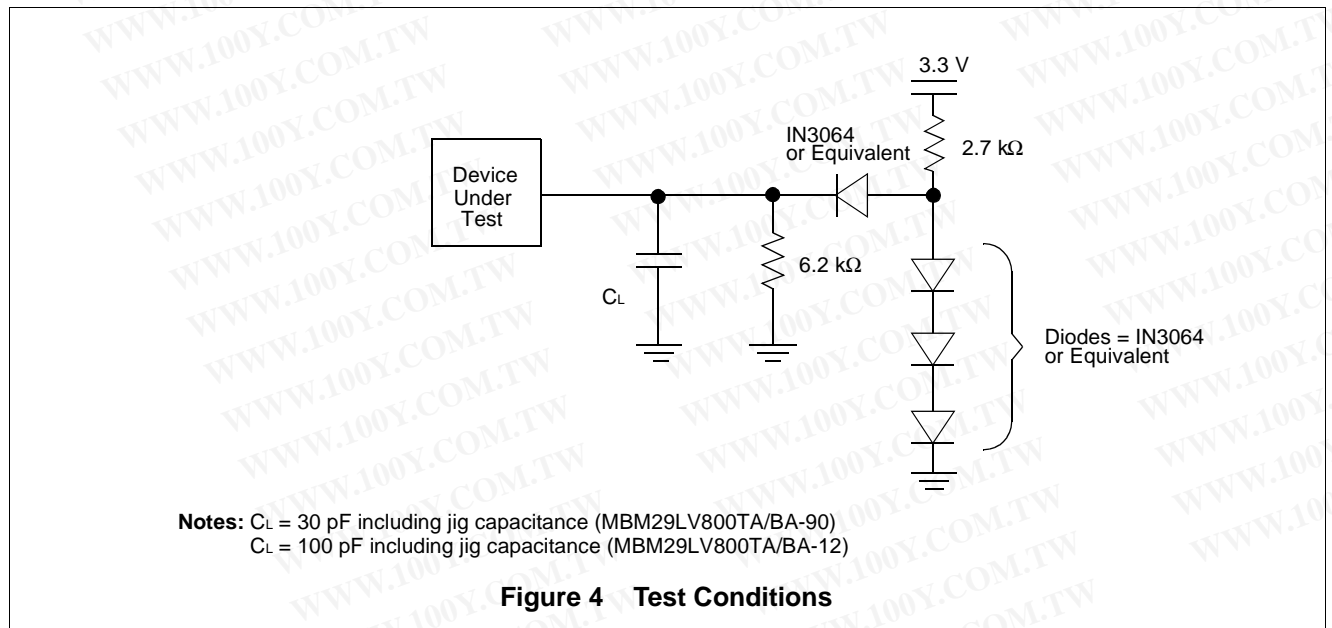


Figure 4 Test Conditions

MBM29LV800TA-90/-12/MBM29LV800BA-90/-12

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• Write/Erase/Program Operations

Parameter Symbols		Description		-90	-12	Unit
JEDEC	Standard					
t _{AVAV}	t _{WC}	Write Cycle Time	Min.	90	120	ns
t _{AVWL}	t _{AS}	Address Setup Time	Min.	0	0	ns
t _{WLAX}	t _{AH}	Address Hold Time	Min.	45	50	ns
t _{DVWH}	t _{DS}	Data Setup Time	Min.	45	50	ns
t _{WHDX}	t _{DH}	Data Hold Time	Min.	0	0	ns
—	t _{OES}	Output Enable Setup Time	Min.	0	0	ns
—	t _{OEHL}	Output Enable Hold Time	Min.	0	0	ns
		Read Toggle and Data Polling	Min.	10	10	ns
t _{GHWL}	t _{GHWL}	Read Recover Time Before Write	Min.	0	0	ns
t _{GHEL}	t _{GHEL}	Read Recover Time Before Write	Min.	0	0	ns
t _{ELWL}	t _{CS}	$\overline{\text{CE}}$ Setup Time	Min.	0	0	ns
t _{WLEL}	t _{WS}	$\overline{\text{WE}}$ Setup Time	Min.	0	0	ns
t _{WHEH}	t _{CH}	$\overline{\text{CE}}$ Hold Time	Min.	0	0	ns
t _{EHWH}	t _{WH}	$\overline{\text{WE}}$ Hold Time	Min.	0	0	ns
t _{WLWH}	t _{WP}	Write Pulse Width	Min.	45	50	ns
t _{ELEH}	t _{CP}	$\overline{\text{CE}}$ Pulse Width	Min.	45	50	ns
t _{WHWL}	t _{WPH}	Write Pulse Width High	Min.	25	30	ns
t _{EHEL}	t _{CPH}	$\overline{\text{CE}}$ Pulse Width High	Min.	25	30	ns
t _{WHWH1}	t _{WHWH1}	Byte Programming Operation	Typ.	8	8	μs
t _{WHWH2}	t _{WHWH2}	Sector Erase Operation (Note 1)	Typ.	1	1	sec
—	t _{VCS}	V _{CC} Setup Time	Min.	50	50	μs
—	t _{VIDR}	Rise Time to V _{ID} (Note 2)	Min.	500	500	ns
—	t _{VLHT}	Voltage Transition Time (Note 2)	Min.	4	4	μs
—	t _{WPP}	Write Pulse Width (Note 2)	Min.	100	100	μs
—	t _{OESP}	$\overline{\text{OE}}$ Setup Time to $\overline{\text{WE}}$ Active (Note 2)	Min.	4	4	μs
—	t _{CSP}	$\overline{\text{CE}}$ Setup Time to $\overline{\text{WE}}$ Active (Note 2)	Min.	4	4	μs
—	t _{RB}	Recover Time From RY/BY	Min.	0	0	ns
—	t _{RP}	RESET Pulse Width	Min.	500	500	ns
—	t _{RH}	RESET Hold Time Before Read	Min.	200	200	ns

(Continued)

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(Continued)

Parameter Symbols		Description		-90	-12	Unit
JEDEC	Standard					
—	t _{FLQZ}	BYTE Switching Low to Output High-Z	Max.	30	40	ns
—	t _{FHQV}	BYTE Switching High to Output Active	Min.	30	40	ns
—	t _{BUSY}	Program/Erase Valid to RY/BY Delay	Max.	90	90	ns
—	t _{EOE}	Delay Time from Embedded Output Enable	Max.	90	120	ns

Notes: 1. This does not include the preprogramming time.

2. This timing is for Sector Protection operation.

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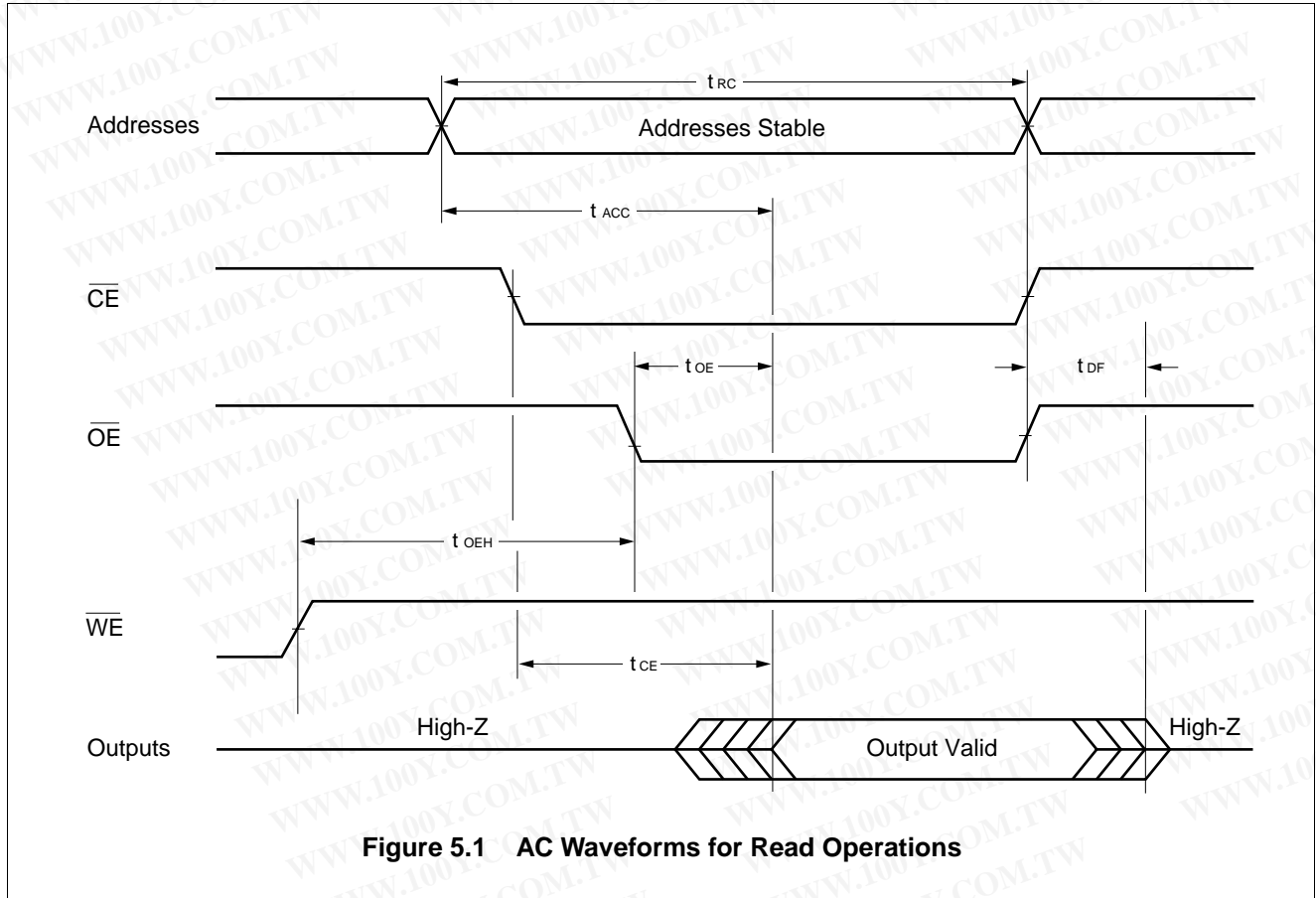
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SWITCHING WAVEFORMS

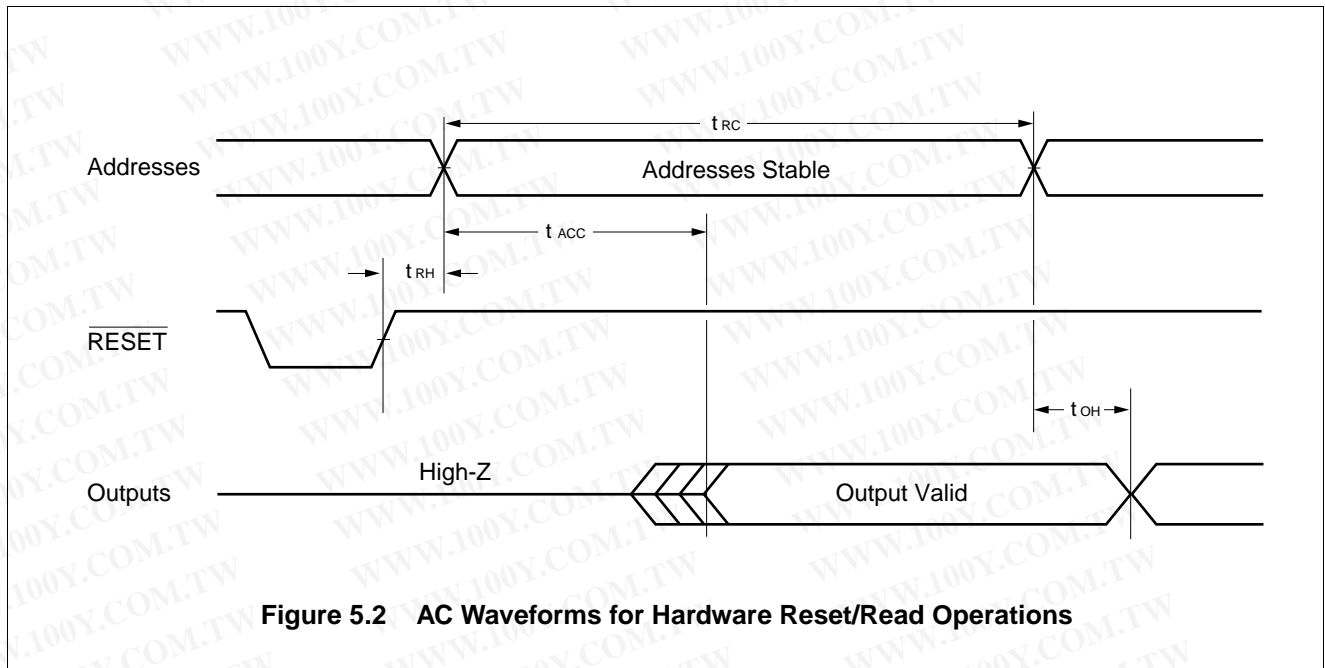
Key to Switching Waveforms

WAVEFORM	INPUTS	OUTPUTS
	Must Be Steady	Will Be Steady
	May Change from H to L	Will Be Changing from H to L
	May Change from L to H	Will Be Changing from L to H
	"H" or "L" Any Change Permitted	Changing State Unknown
	Does Not Apply	Center Line is High-Impedance "Off" State

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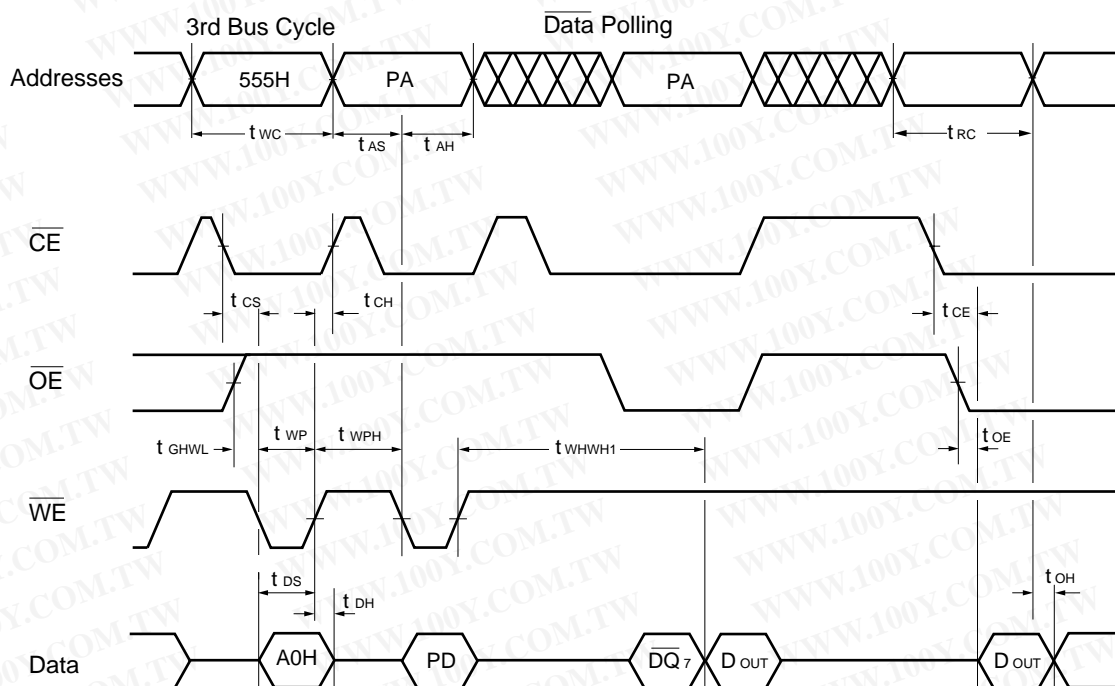


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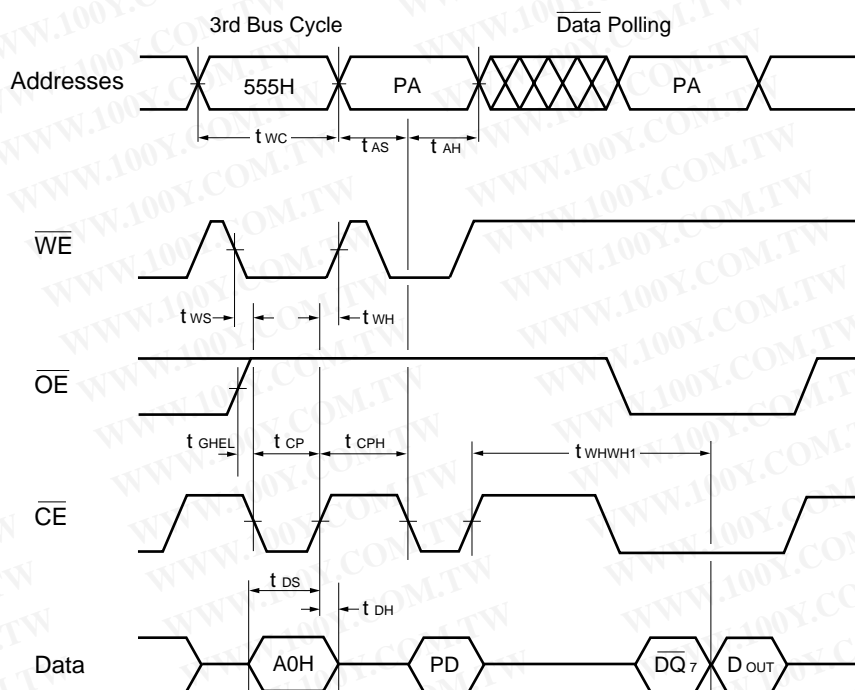


- Notes:**
1. PA is address of the memory location to be programmed.
 2. PD is data to be programmed at byte address.
 3. \overline{DQ}_7 is the output of the complement of the data written to the device.
 4. DOUT is the output of the data written to the device.
 5. Figure indicates last two bus cycles out of four bus cycle sequence.
 6. These waveforms are for the $\times 16$ mode. (The addresses differ from $\times 8$ mode.)

Figure 6 AC Waveforms for Alternate WE Controlled Program Operations

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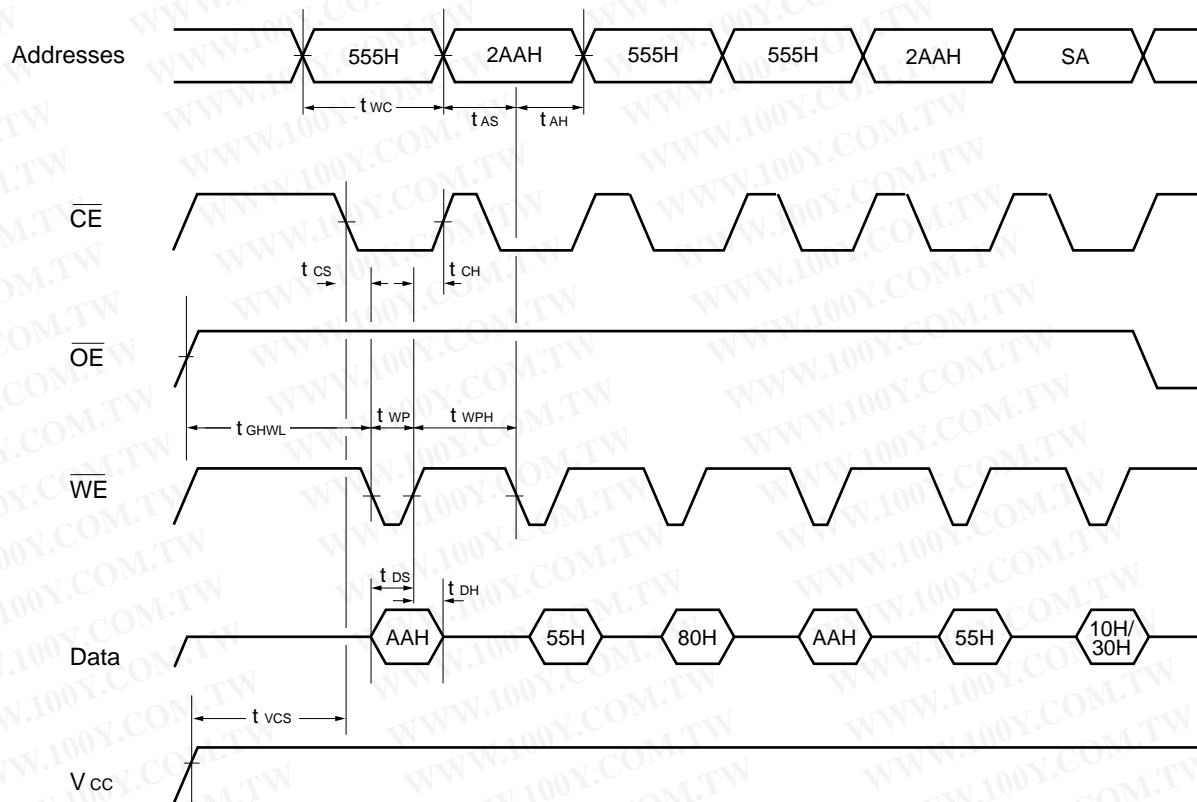


- Notes:**
1. PA is address of the memory location to be programmed.
 2. PD is data to be programmed at byte address.
 3. \overline{DQ}_7 is the output of the complement of the data written to the device.
 4. DOUT is the output of the data written to the device.
 5. Figure indicates last two bus cycles out of four bus cycle sequence.
 6. These waveforms are for the $\times 16$ mode. (The addresses differ from $\times 8$ mode.)

Figure 7 AC Waveforms for Alternate \overline{CE} Controlled Program Operations

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- Notes:**
1. SA is the sector address for Sector Erase. Addresses = 555H (Word), AAH (Byte) for Chip Erase.
 2. These waveforms are for the $\times 16$ mode. (The addresses differ from $\times 8$ mode.)

Figure 8 AC Waveforms Chip/Sector Erase Operations

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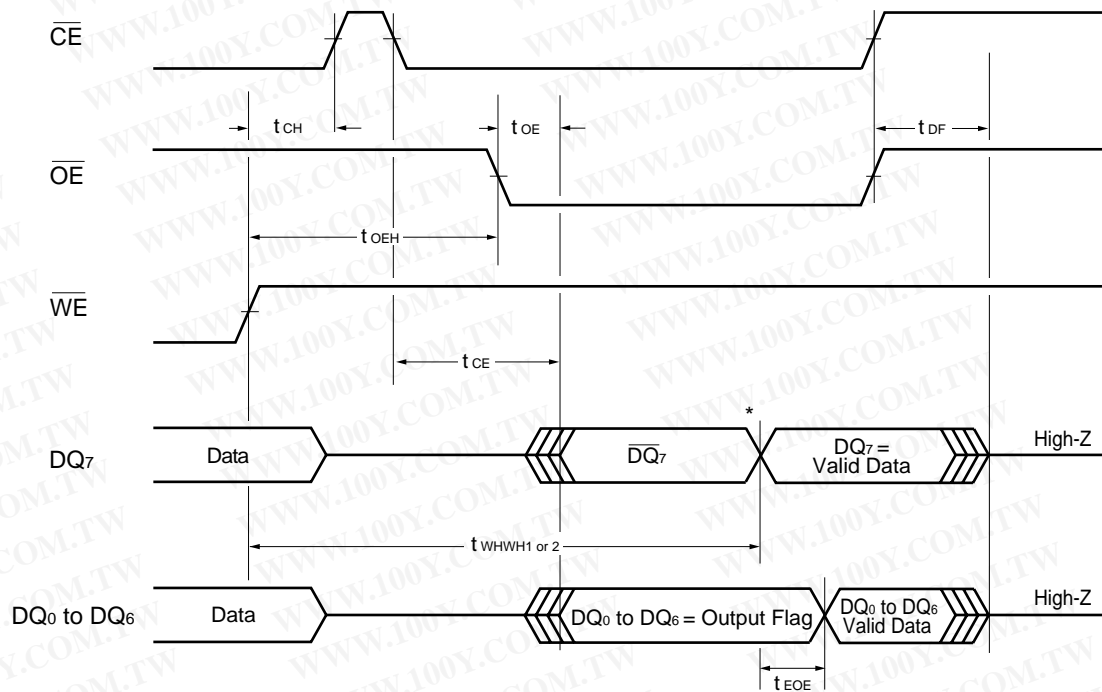


Figure 9 AC Waveforms for Data Polling during Embedded Algorithm Operations

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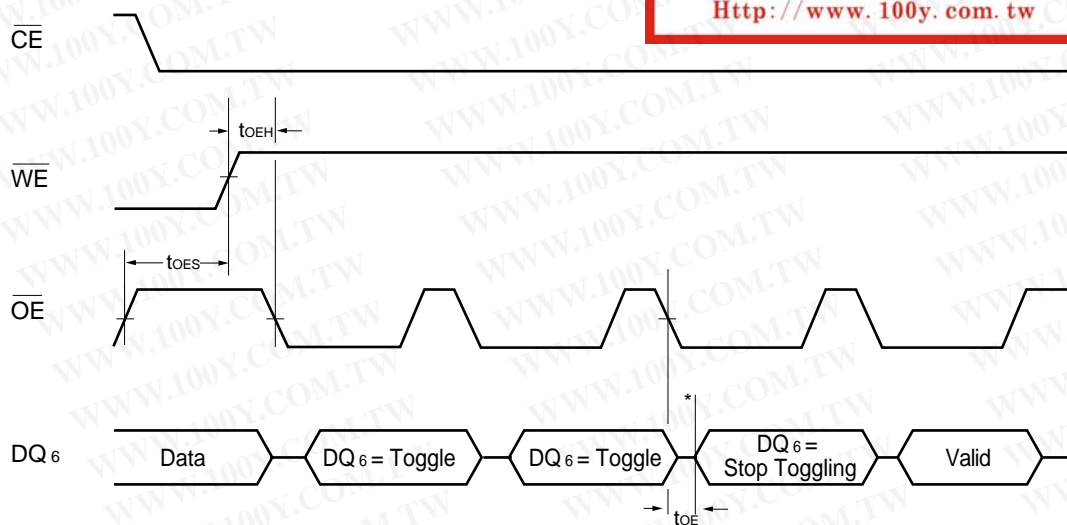


Figure 10 AC Waveforms for Toggle Bit I during Embedded Algorithm Operations

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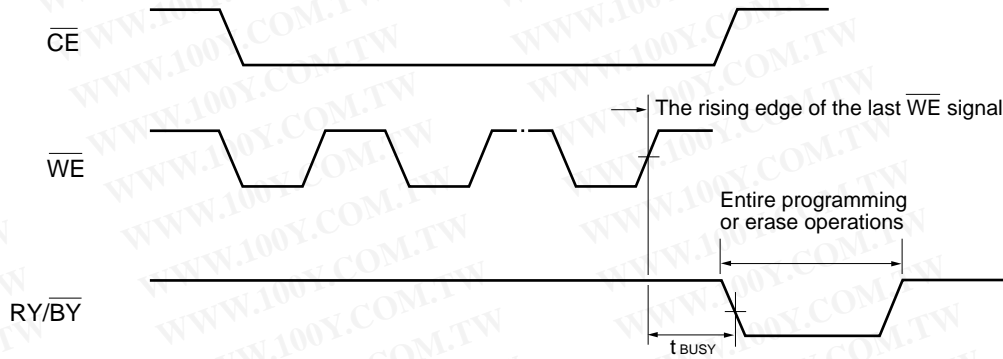


Figure 11 $\overline{RY/BY}$ Timing Diagram during Program/Erase Operations

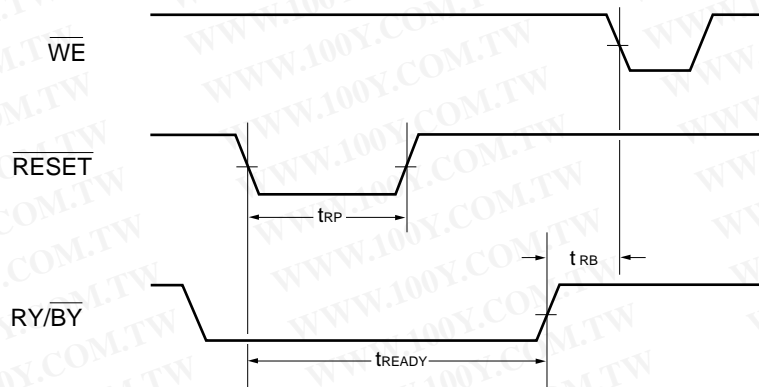


Figure 12 $\overline{RESET}/\overline{RY/BY}$ Timing Diagram

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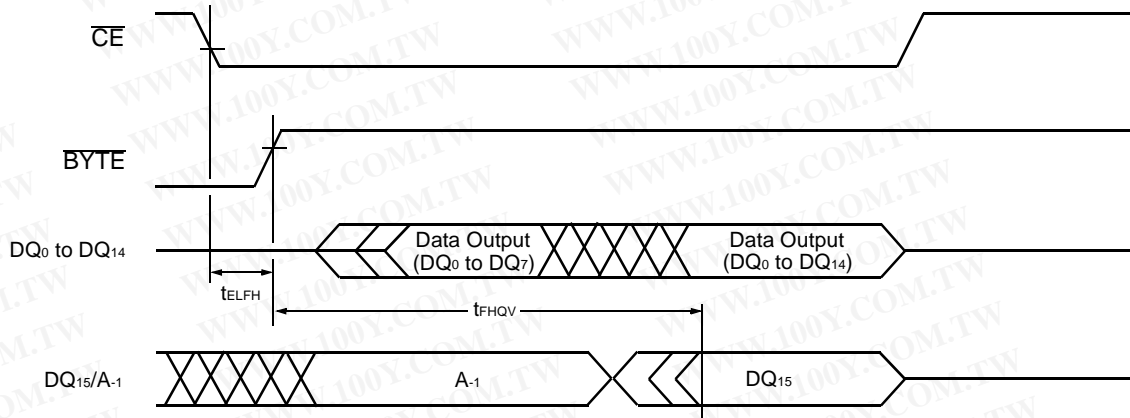


Figure 13 Timing Diagram for Word Mode Configuration

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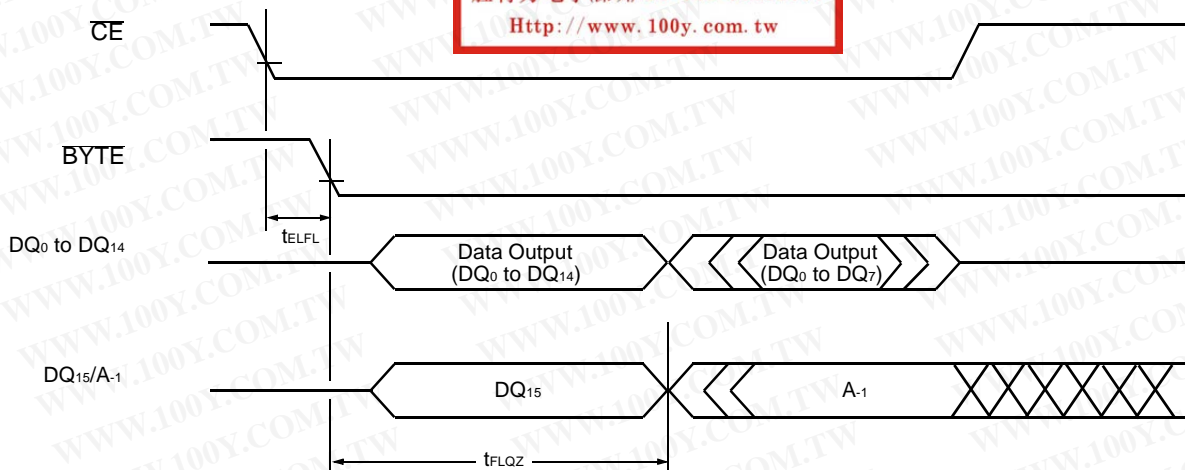


Figure 14 Timing Diagram for Byte Mode Configuration

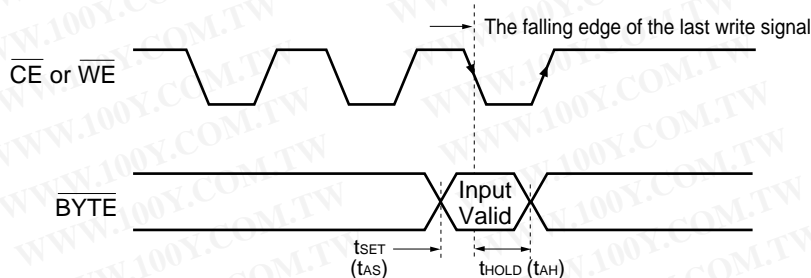
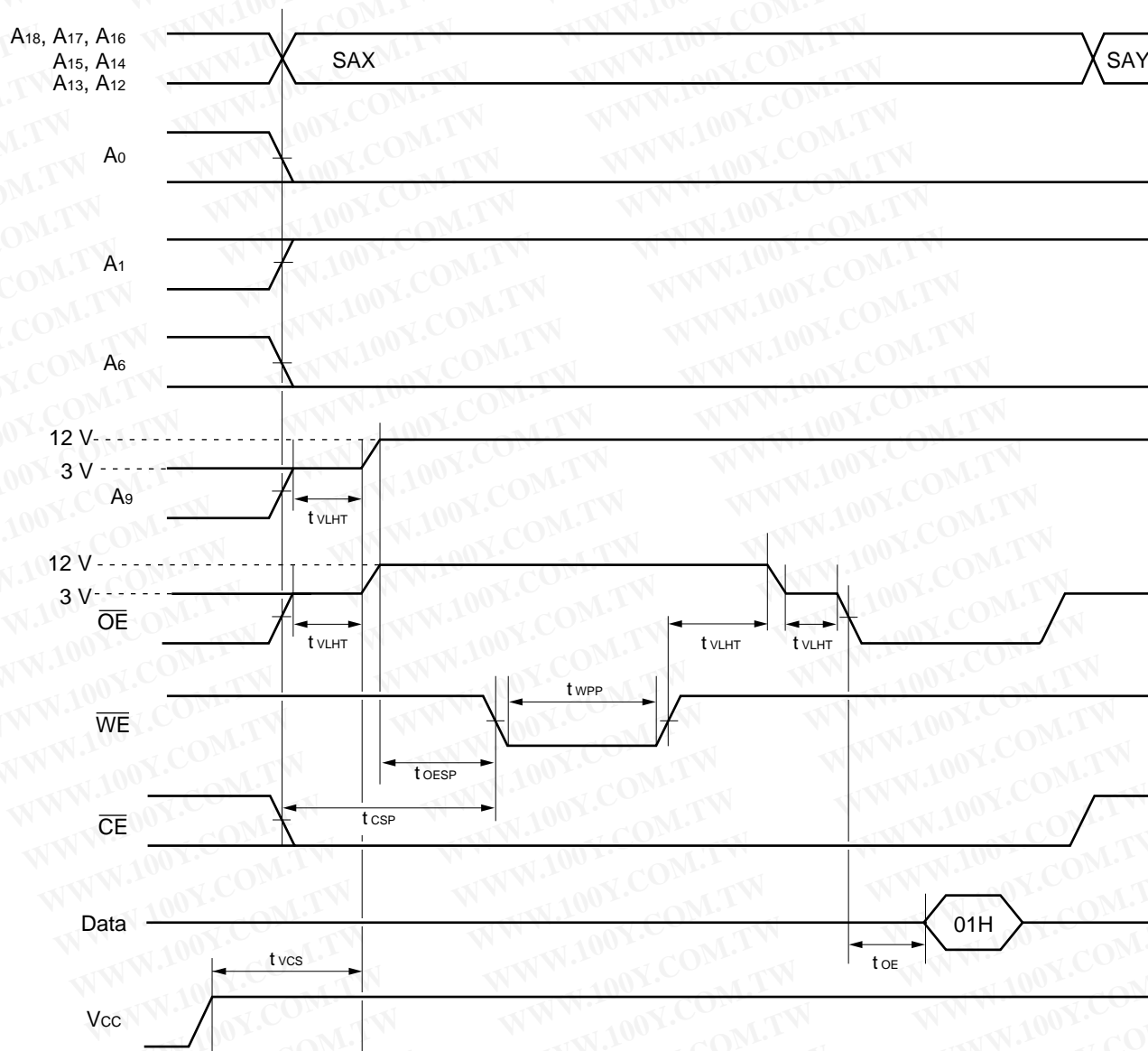


Figure 15 BYTE Timing Diagram for Write Operations

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SAX : Sector Address for initial sector

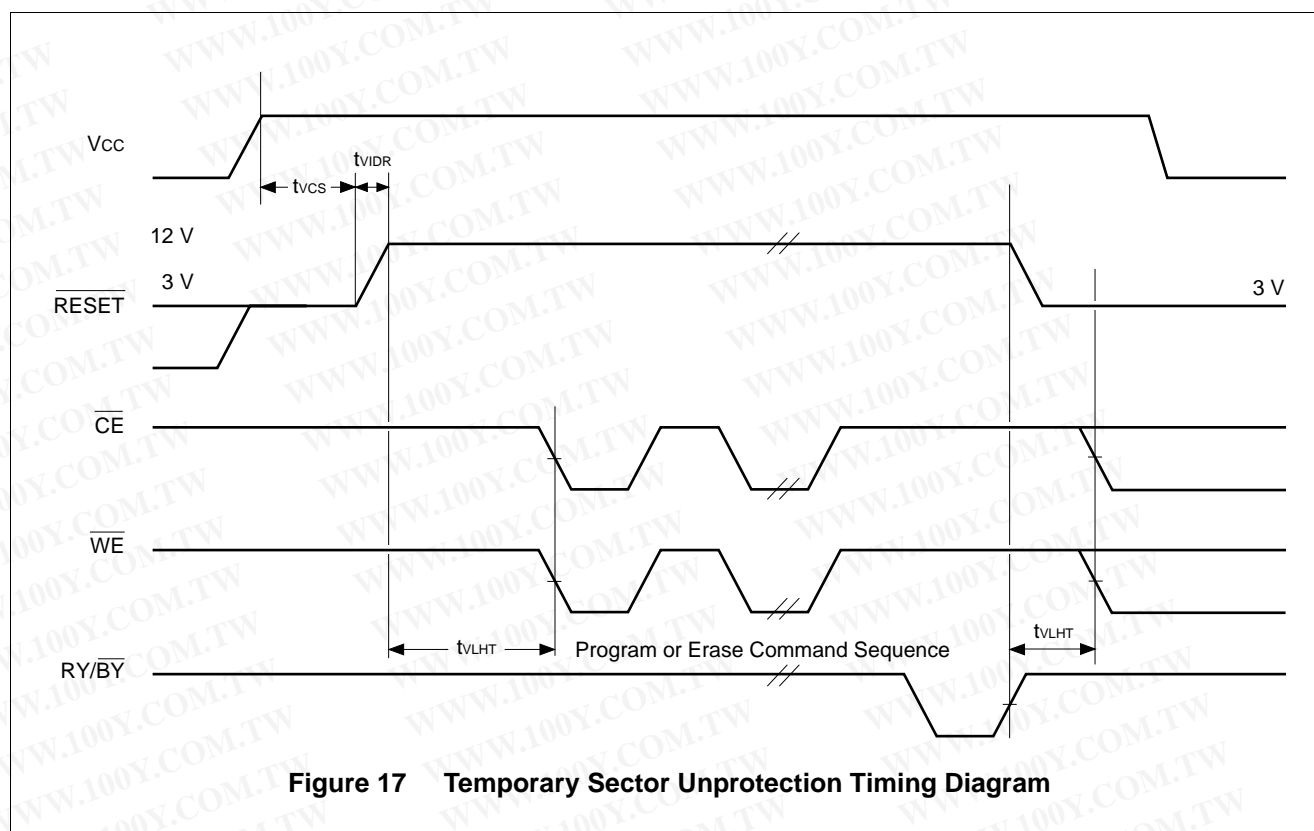
SAY : Sector Address for next sector

Note: A-1 is V_{IL} on byte mode.

Figure 16 AC Waveforms for Sector Protection Timing Diagram

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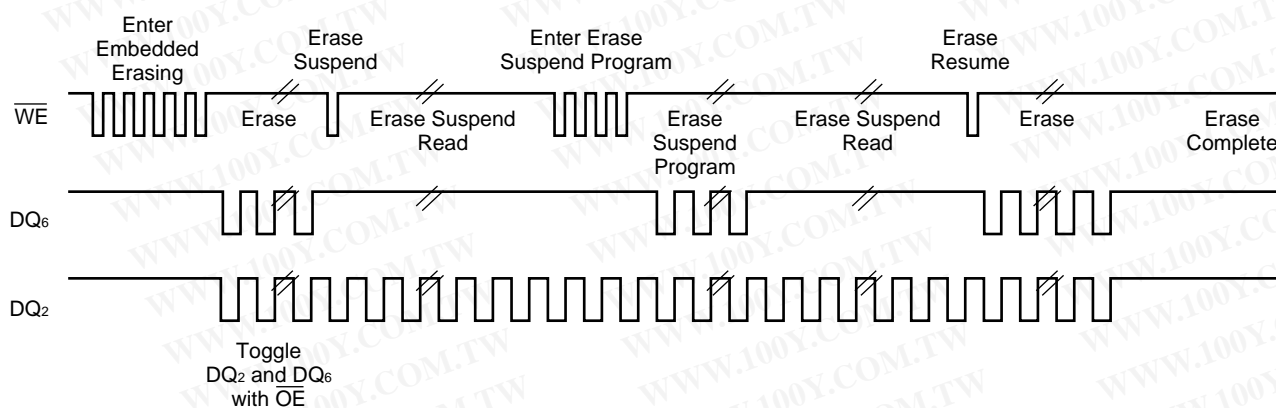
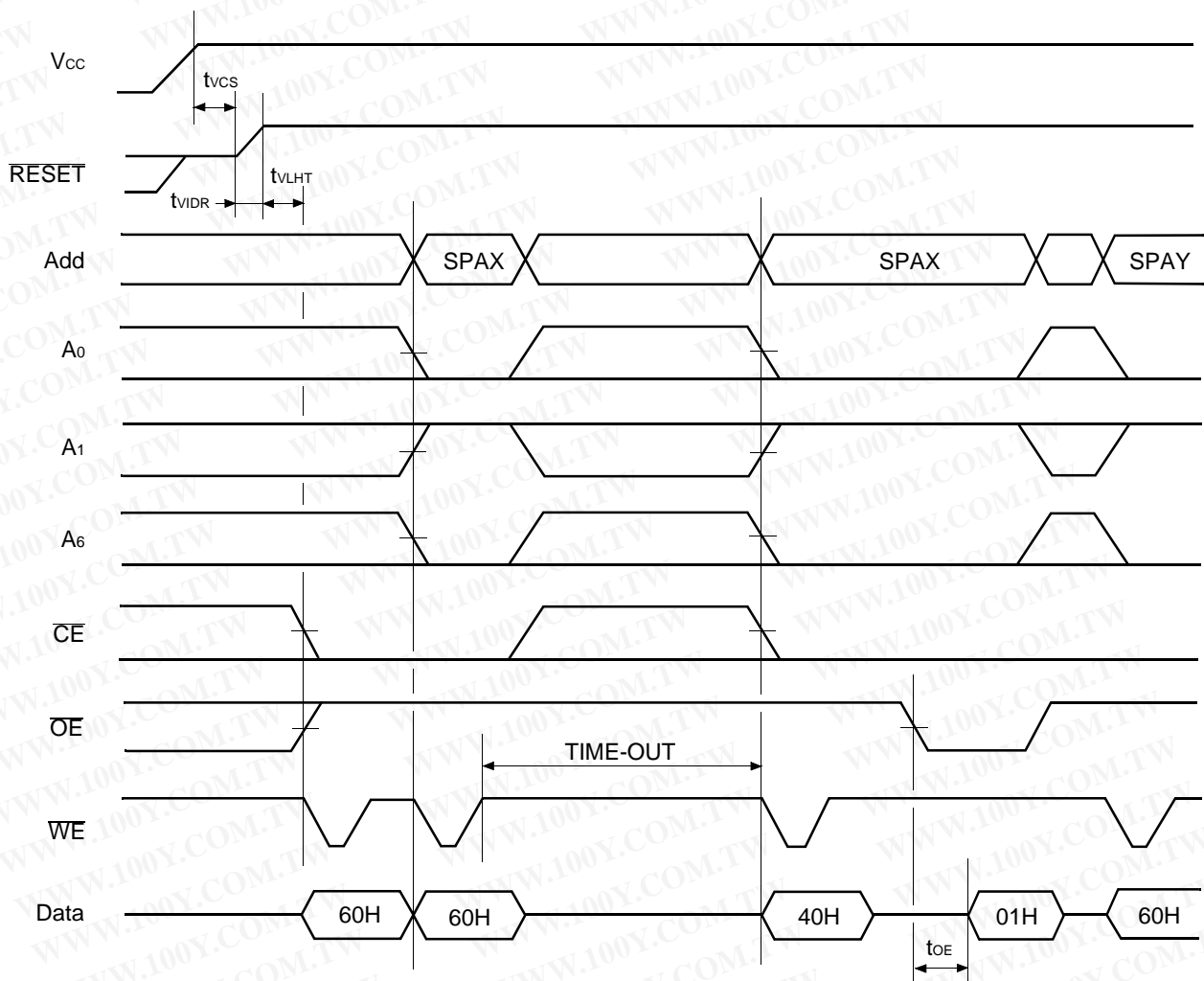


Figure 18 DQ₂ vs. DQ₆

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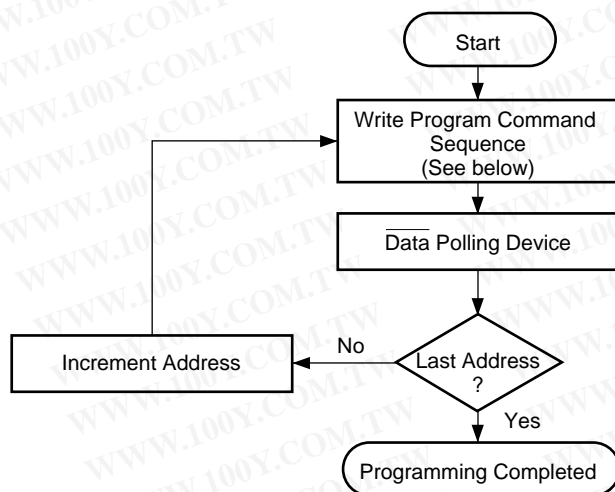
SPAX : Sector Address to be protected
 SPAY : Next Sector Address to be protected
 TIME-OUT : Time-Out window = 150 μ s (min)

Figure 19 Extended Sector Protection Timing Diagram

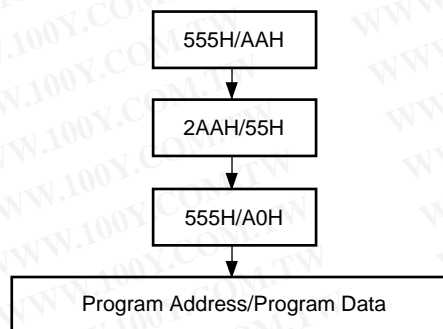
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EMBEDDED ALGORITHMS



Program Command Sequence* (Address/Command):



* : The sequence is applied for $\times 16$ mode.
The addresses differ from $\times 8$ mode.

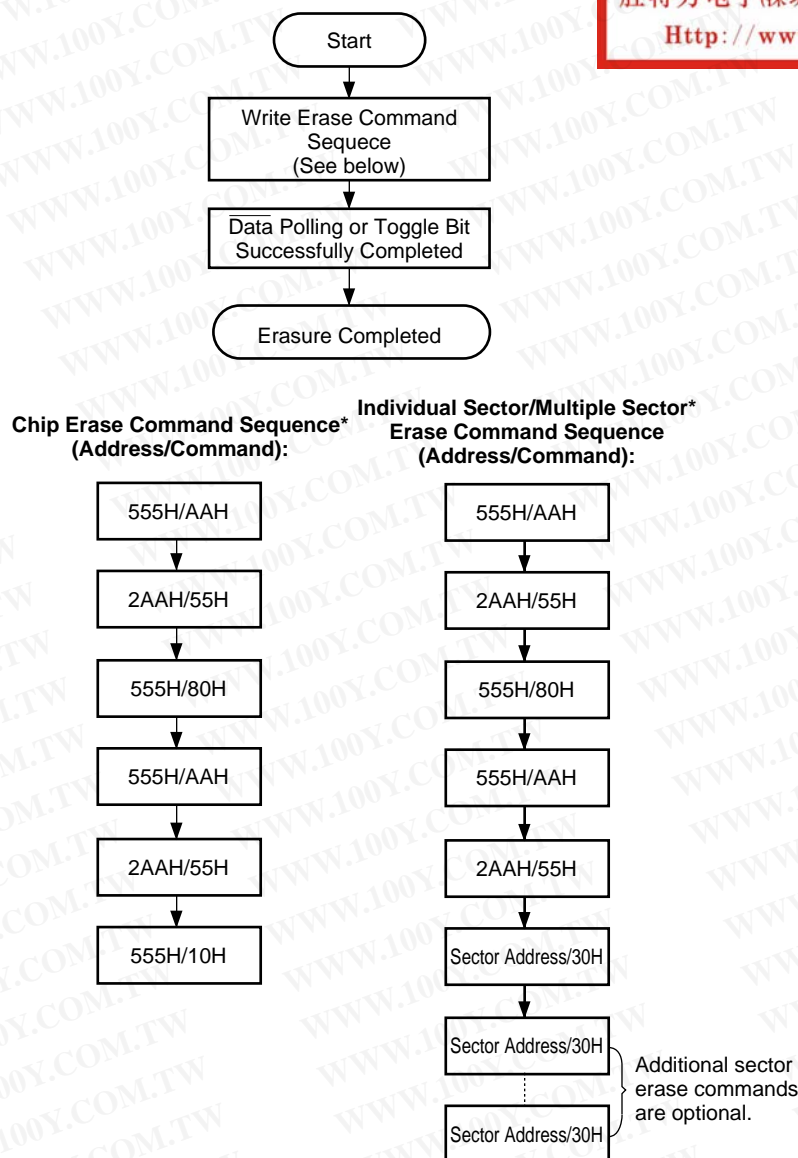
Figure 20 Embedded Program™ Algorithm

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EMBEDDED ALGORITHMS

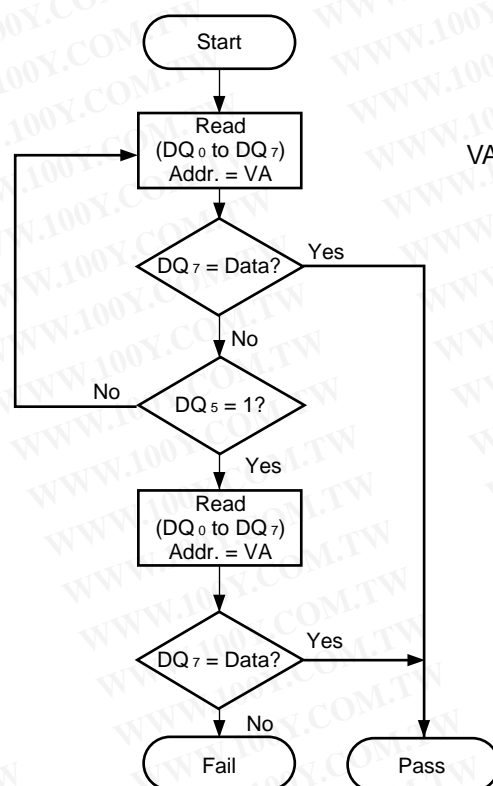
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* : The sequence is applied for $\times 16$ mode.
 The addresses differ from $\times 8$ mode.

Figure 21 Embedded Erase™ Algorithm

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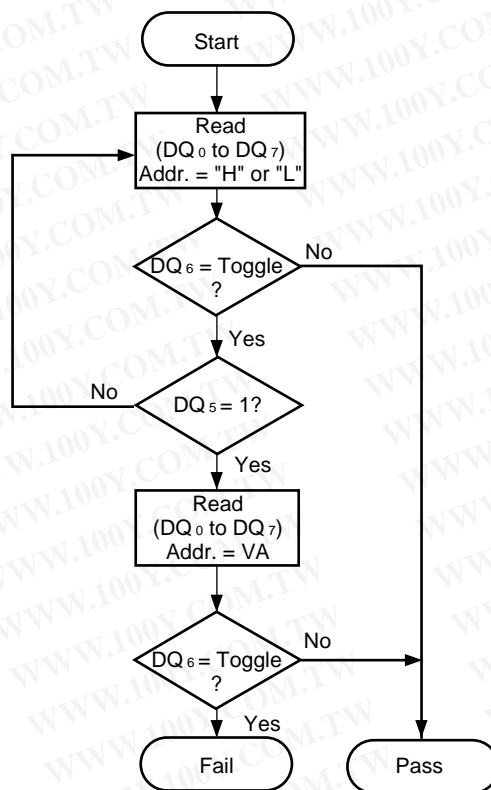
VA = Byte address for programming
 = Any of the sector addresses within
 the sector being erased during
 sector erase or multiple sector
 erases operation
 = Any of the sector addresses within
 the sector not being protected
 during chip erase

Note: DQ₇ is rechecked even if DQ₅ = "1" because DQ₇ may change simultaneously with DQ₅.

Figure 22 Data Polling Algorithm

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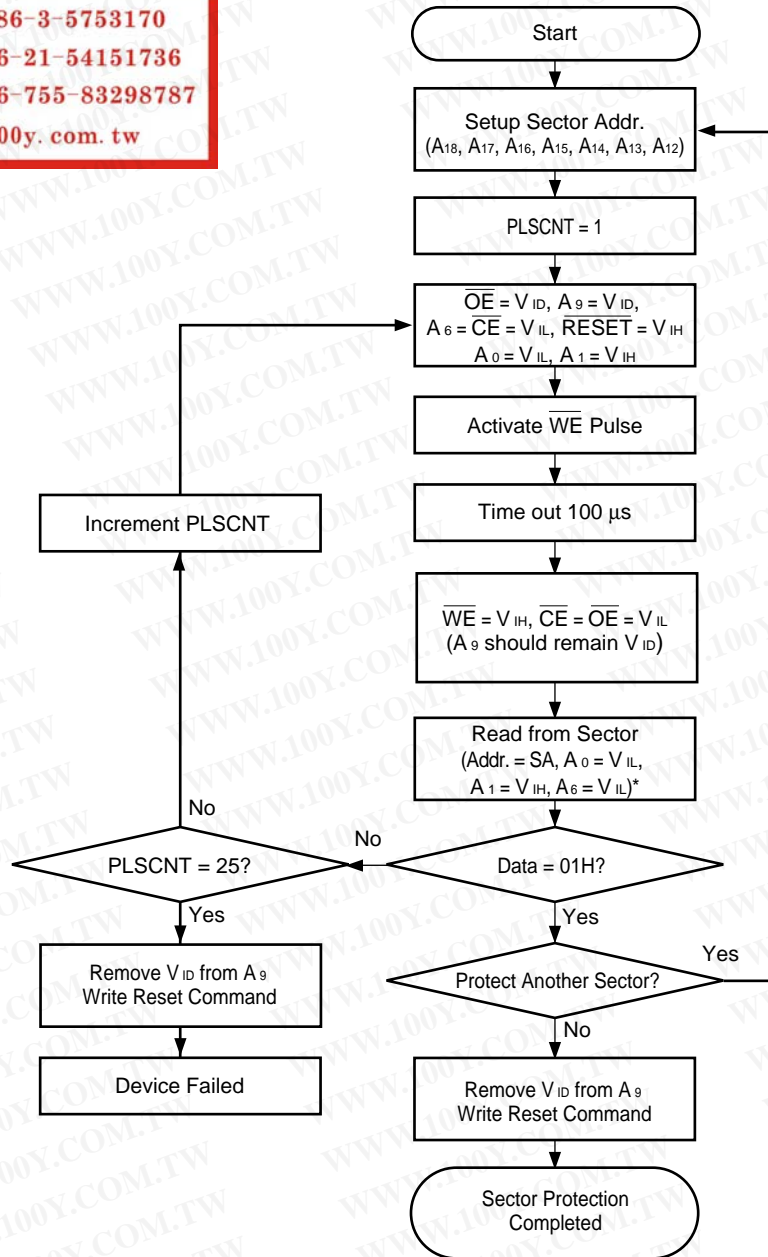
Note: DQ₆ is rechecked even if DQ₅ = "1" because DQ₆ may stop toggling at the same time as DQ₅ changing to "1".

Figure 23 Toggle Bit Algorithm

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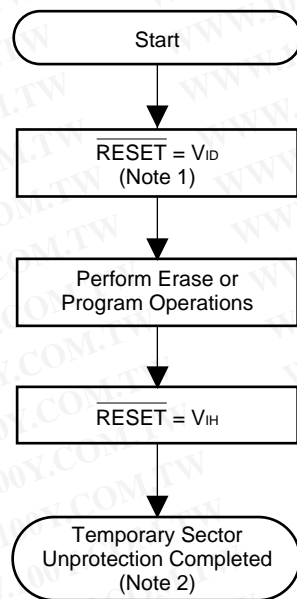
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* : A-1 is V_{IL} on byte mode.

Figure 24 Sector Protection Algorithm

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- Notes:** 1. All protected sectors are unprotected.
 2. All previously protected sectors are protected once again.

Figure 25 Temporary Sector Unprotection Algorithm

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FAST MODE ALGORITHM

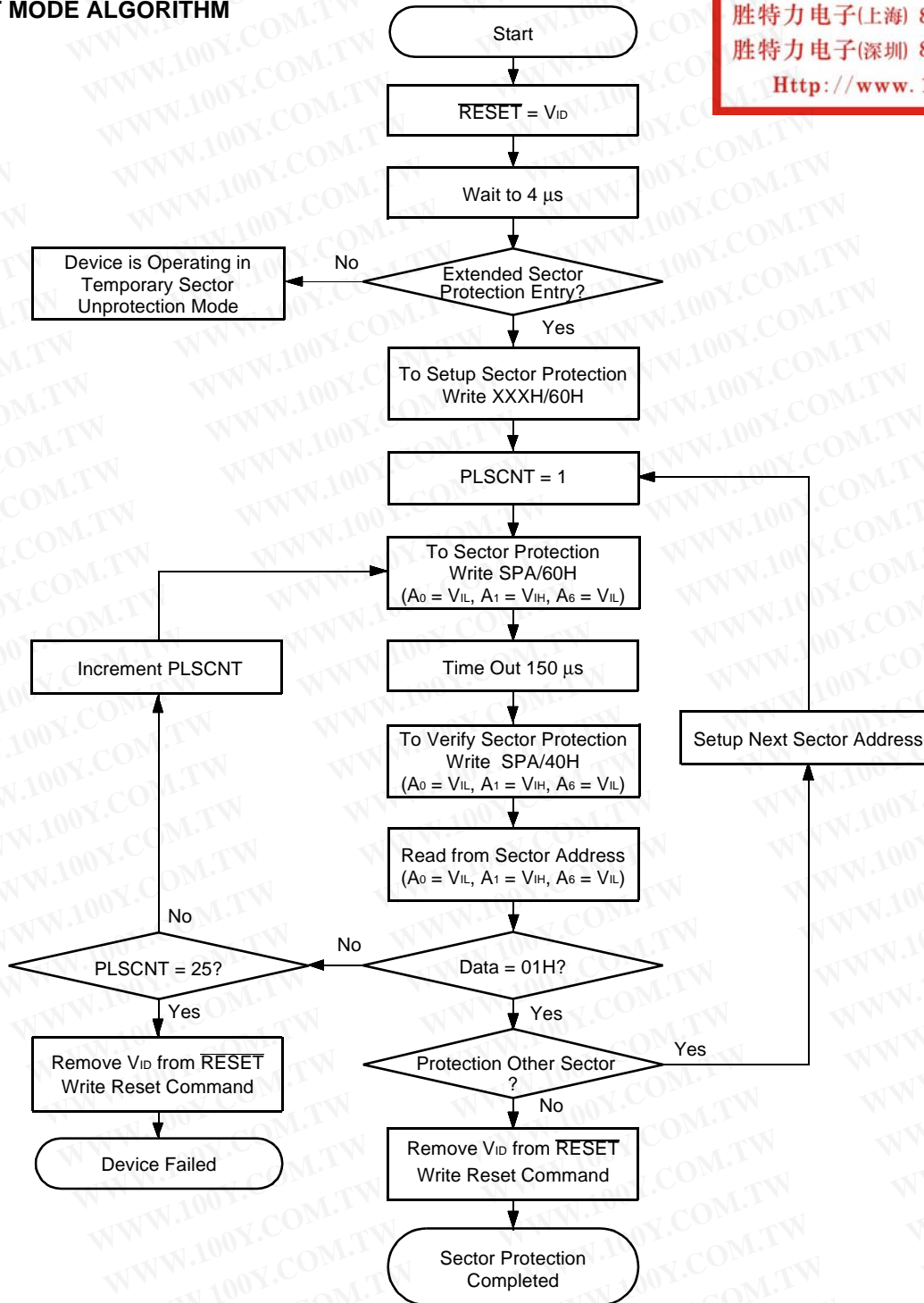
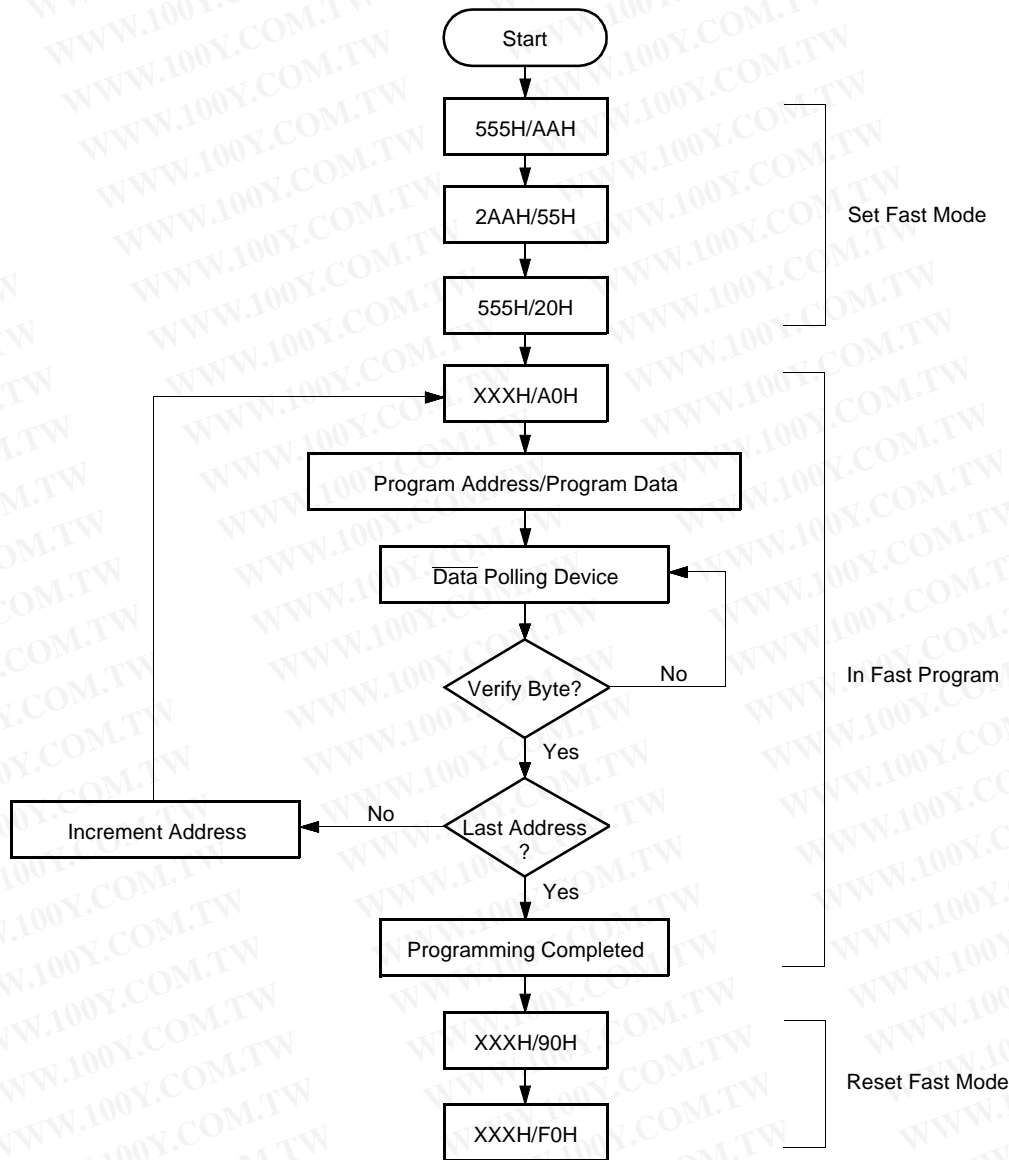


Figure 26 Extended Sector Protection Algorithm

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FAST MODE ALGORITHM



* : The sequence is applied for $\times 16$ mode.
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Figure 27 Embedded Program™ Algorithm for Fast Mode

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■ ERASE AND PROGRAMMING PERFORMANCE

Parameter	Limits			Unit	Comments
	Min.	Typ.	Max.		
Sector Erase Time	—	1	15	sec	Excludes programming time prior to erasure
Word Programming Time	—	16	5200	μs	Excludes system-level overhead
Byte Programming Time	—	8	3600	μs	
Chip Programming Time	—	8.4	50	sec	Excludes system-level overhead
Program/Erase Cycle	100,000	—	—	cycles	—

■ TSOP(I) PIN CAPACITANCE

Parameter Symbol	Parameter Description	Test Setup	Typ.	Max.	Unit
C _{IN}	Input Capacitance	V _{IN} = 0	7.5	9.5	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0	8	10	pF
C _{IN2}	Control Pin Capacitance	V _{IN} = 0	10	13	pF

Note: Test conditions T_A = 25°C, f = 1.0 MHz

■ SOP PIN CAPACITANCE

Parameter Symbol	Parameter Description	Test Setup	Typ.	Max.	Unit
C _{IN}	Input Capacitance	V _{IN} = 0	7.5	9.5	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0	8	10	pF
C _{IN2}	Control Pin Capacitance	V _{IN} = 0	10	13	pF

Note: Test conditions T_A = 25°C, f = 1.0 MHz

■ SON PIN CAPACITANCE

Parameter Symbol	Parameter Description	Test Setup	Typ.	Max.	Unit
C _{IN}	Input Capacitance	V _{IN} = 0	7.5	9.5	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0	8	10	pF
C _{IN2}	Control Pin Capacitance	V _{IN} = 0	10	13	pF

Note: Test conditions T_A = 25°C, f = 1.0 MHz

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■ FBGA PIN CAPACITANCE

Parameter Symbol	Parameter Description	Test Setup	Typ.	Max.	Unit
C _{IN}	Input Capacitance	V _{IN} = 0	T.B.D.	T.B.D.	pF
C _{OUT}	Output Capacitance	V _{OUT} = 0	T.B.D.	T.B.D.	pF
C _{IN2}	Control Pin Capacitance	V _{IN} = 0	T.B.D.	T.B.D.	pF

Note: Test conditions T_A = 25°C, f = 1.0 MHz

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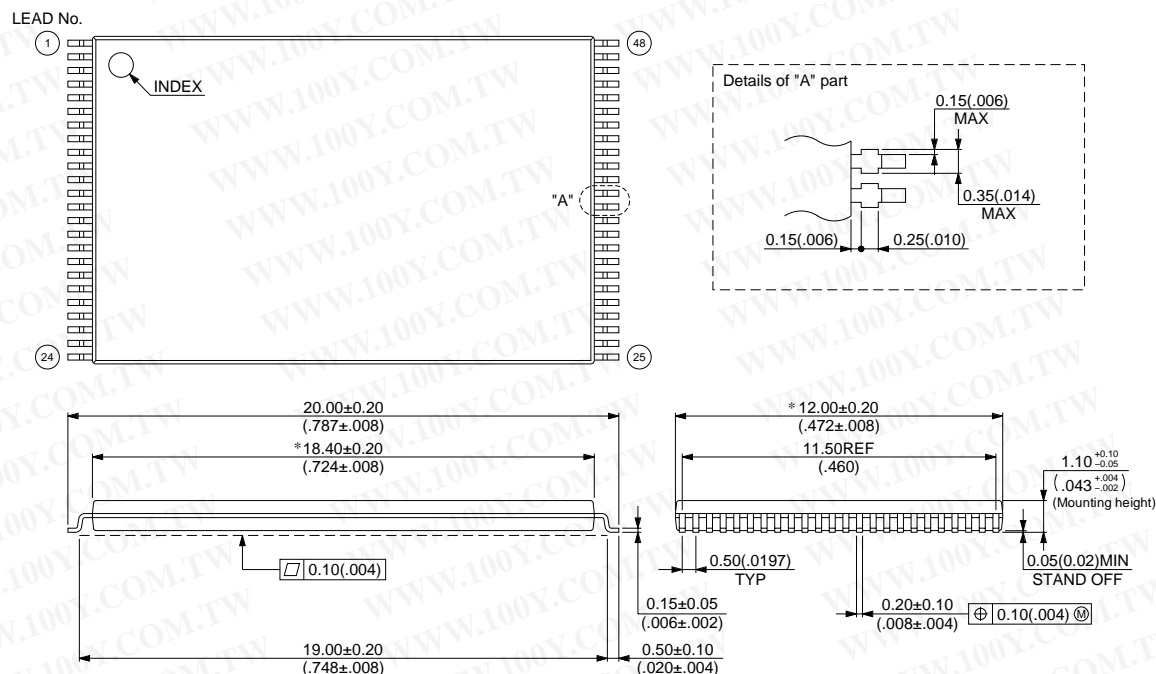
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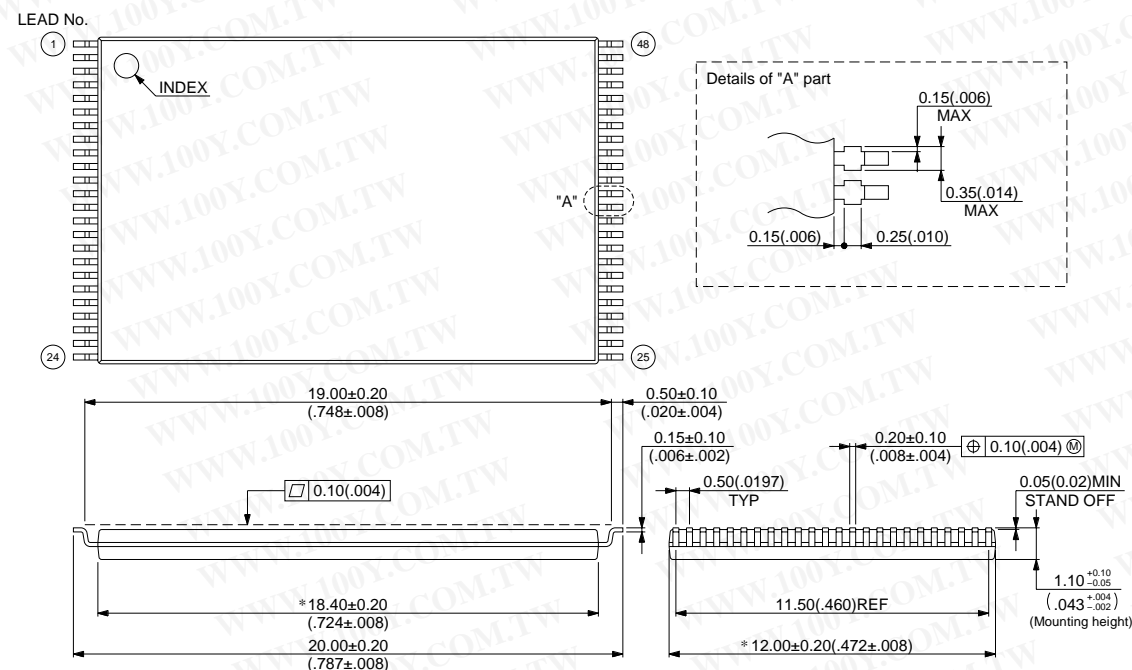


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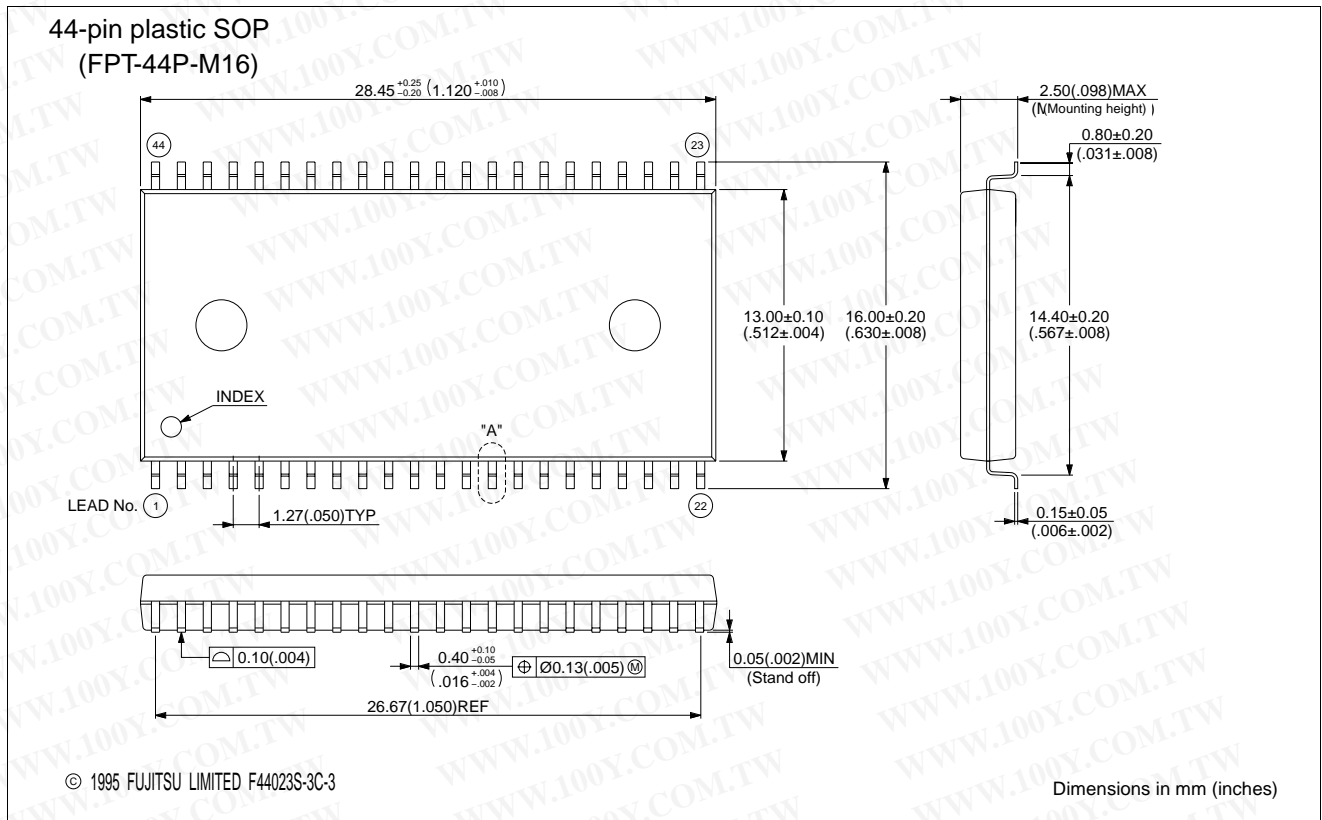


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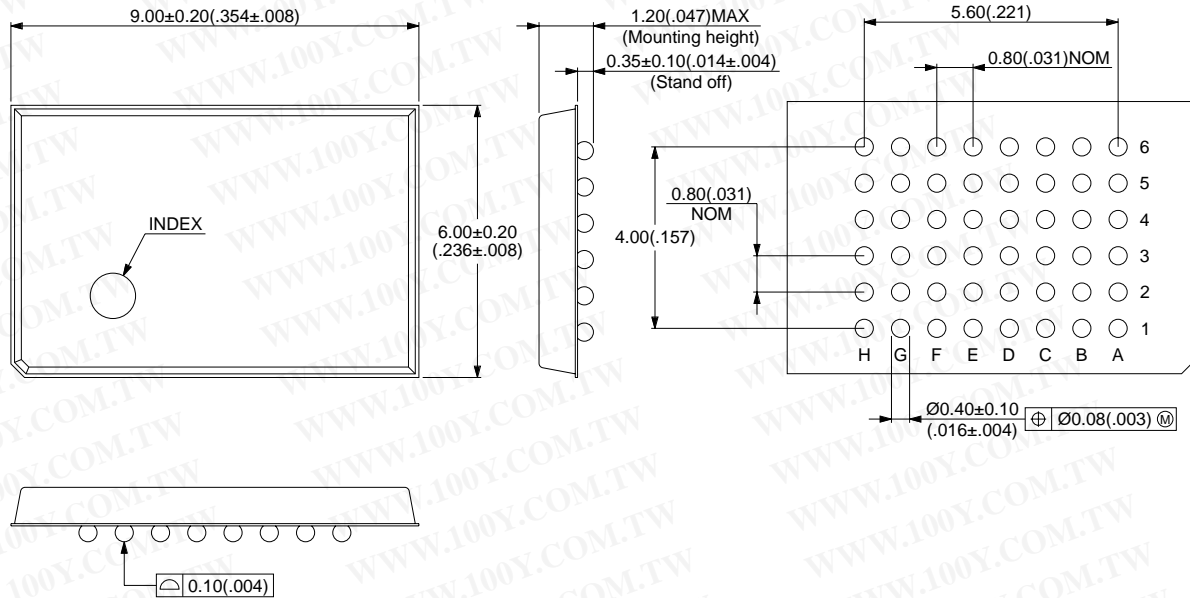
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Note: The actual shape of corners may differ from the dimension.



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